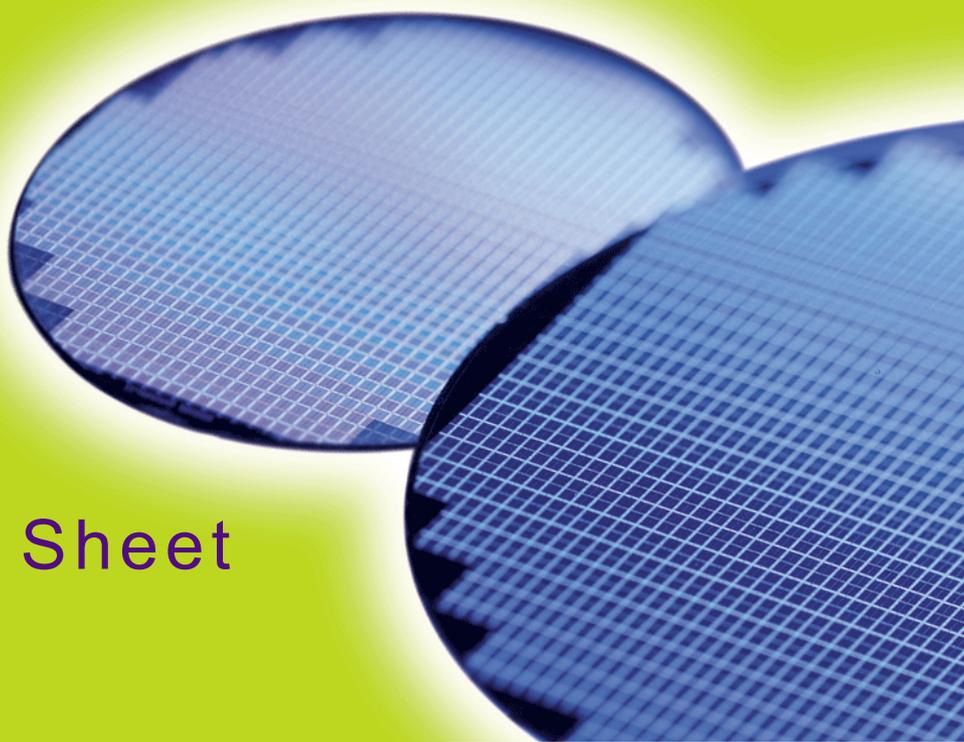


[查询"HYS64T64000HU-3.7-A"供应商](#)

HYS64T32x00HU-[3/3S/3.7/5]-A
HYS[64/72]T64x00HU-[3/3S/3.7/5]-A
HYS[64/72]T128x20HU-[3/3S/3.7/5]-A

*240-Pin Unbuffered DDR2 SDRAM Modules
DDR2 SDRAM
RoHS Compliant*



Internet Data Sheet

Rev. 1.41

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

HYS64T32x00HU-[3/3S/3.7/5]-A, HYS[64/72]T64x00HU-[3/3S/3.7/5]-A, HYS[64/72]T128x20HU-[3/3S/3.7/5]-A	
Revision History: 2007-01, Rev. 1.41	
Page	Subjects (major changes since last revision)
All	Adapted internet edition
42, 43	Table 30 Footnote 4 updated.
Previous Revision: 2007-01, Rev. 1.40	
All	Added Products HYS64T[32/64/128]9x0HU-[3S/3.7]-A
Previous Revision: 2006-09, Rev. 1.32	
All	Qimonda update
Previous Revision: 2006-03, Rev. 1.31	
43, 44, 45, 46	Editorial changes
29, 34, 37	Updated AC Timing Parameter table DQS DQ skew value is the max. value
48	Added 50 ohm data
Previous Revision: 2005-08, Rev. 1.3	

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Please send your proposal (including a reference to this document) to:

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1 Overview

This chapter gives an overview of the 240-Pin Unbuffered DDR2 SDRAM Modules product family and describes its main characteristics.

1.1 Features

- 240-Pin PC2-5300, PC2-4200 and PC2-3200 DDR2 SDRAM memory modules for use as main memory when installed in systems such as mobile personal computers.
- 32M × 64, 64M × 64, 64M × 72, 128M × 64, 128M × 72 module organization, and 32M × 16, 64M × 8 chip organization
- 256 MByte, 512 MByte and 1 GByte modules built with 512-Mbit DDR2 SDRAMs in P-TFBGA-60 and P-TFBGA-84 chipsize packages
- All Speed grades faster than DDR2-400 comply with DDR2-400 timing specifications.
- Standard Double-Data-Rate-Two Synchronous DRAMs (DDR2 SDRAM) with a single + 1.8 V (± 0.1 V) power supply
- Programmable CAS Latencies (3, 4 and 5), Burst Length (8 & 4) and Burst Type
- Auto Refresh (CBR) and Self Refresh
- All inputs and outputs SSTL_1.8 compatible
- Off-Chip Driver Impedance Adjustment (OCD) and On-Die Termination (ODT)
- Serial Presence Detect with E²PROM
- Dimensions (nominal): 30 mm high, 133.35 mm wide
- Based on standard reference layouts Raw Card "A", "B", "C", "D", "E", "F" and "G"
- RoHS compliant products¹⁾

TABLE 1
Performance table for -3(S)

Product Type Speed Code			-3	-3S	Unit
Speed Grade			PC2-5300 4-4-4	PC2-5300 5-5-5	—
Max. Clock Frequency	@CL5	f_{CK5}	333	333	MHz
	@CL4	f_{CK4}	333	266	MHz
	@CL3	f_{CK3}	200	200	MHz
Min. RAS-CAS-Delay		t_{RCD}	12	15	ns
Min. Row Precharge Time		t_{RP}	12	15	ns
Min. Row Active Time		t_{RAS}	45	45	ns
Min. Row Cycle Time		t_{RC}	57	60	ns

1) RoHS Compliant Product: Restriction of the use of certain hazardous substances (RoHS) in electrical and electronic equipment as defined in the directive 2002/95/EC issued by the European Parliament and of the Council of 27 January 2003. These substances include mercury, lead, cadmium, hexavalent chromium, polybrominated biphenyls and polybrominated biphenyl ethers.

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

TABLE 2
Performance table for -3.7

Product Type Speed Code			-3.7	Unit
Speed Grade			PC2-4200 4-4-4	—
Max. Clock Frequency	@CL5	f_{CK5}	266	MHz
	@CL4	f_{CK4}	266	MHz
	@CL3	f_{CK3}	200	MHz
Min. RAS-CAS-Delay		t_{RCD}	15	ns
Min. Row Precharge Time		t_{RP}	15	ns
Min. Row Active Time		t_{RAS}	45	ns
Min. Row Cycle Time		t_{RC}	60	ns

TABLE 3
Performance table for -5

Product Type Speed Code			-5	Unit
Speed Grade			PC2-3200 3-3-3	—
max. Clock Frequency	@CL5	f_{CK5}	200	MHz
	@CL4	f_{CK4}	200	MHz
	@CL3	f_{CK3}	200	MHz
min. RAS-CAS-Delay		t_{RCD}	15	ns
min. Row Precharge Time		t_{RP}	15	ns
min. Row Active Time		t_{RAS}	40	ns
min. Row Cycle Time		t_{RC}	55	ns

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

1.2 Description

The Qimonda HYS[64/72]T[32/64/128]0x0HU-[3/.../5]-A module family are unbuffered DIMM modules "UDIMMs" with 30,0 mm height based on DDR2 technology. DIMMs are available as non-ECC modules in 32M × 64 (256MB), 64M × 64 (512MB), 128M × 64 (1GB) and as ECC modules in 64M × 72 (512MB), 128M × 72 (1GB) organization and density, intended for mounting into 240-pin connector sockets.

The memory array is designed with 512-Mbit Double-Data-Rate-Two (DDR2) Synchronous DRAMs. Decoupling capacitors are mounted on the PCB board. The DIMMs feature serial presence detect based on a serial E²PROM device using the 2-pin I²C protocol. The first 128 bytes are programmed with configuration data and are write protected; the second 128 bytes are available to the customer.



TABLE 4
Ordering Information for RoHS Compliant Products

Product Type ¹⁾	Compliance Code ²⁾	Description	SDRAM Technology
PC2-5300			
HYS64T32000HU-3-A	256MB 1R×16 PC2-5300U-444-12-C1	1 Rank, Non-ECC	512 Mbit (×16)
HYS64T64000HU-3-A	512MB 1R×8 PC2-5300U-444-12-D0	1 Rank, Non-ECC	512 Mbit (×8)
HYS72T64000HU-3-A	512MB 1R×8 PC2-5300E-444-12-F0	1 Rank, ECC	512 Mbit (×8)
HYS64T128020HU-3-A	1GB 2R×8 PC2-5300U-444-12-E0	2 Ranks, Non-ECC	512 Mbit (×8)
HYS72T128020HU-3-A	1GB 2R×8 PC2-5300E-444-12-G0	2 Ranks, ECC	512 Mbit (×8)
HYS64T32000HU-3S-A	256MB 1R×16 PC2-5300U-555-12-C1	1 Rank, Non-ECC	512 Mbit (×16)
HYS64T32900HU-3S-A	256MB 1R×16 PC2-5300U-555-12-C1	1 Rank, Non-ECC	512 Mbit (×16)
HYS64T64000HU-3S-A	512MB 1R×8 PC2-5300U-555-12-D0	1 Rank, Non-ECC	512 Mbit (×8)
HYS64T64900HU-3S-A	512MB 1R×8 PC2-5300U-555-12-D0	1 Rank, Non-ECC	512 Mbit (×8)
HYS72T64000HU-3S-A	512MB 1R×8 PC2-5300E-555-12-F0	1 Rank, ECC	512 Mbit (×8)
HYS64T128020HU-3S-A	1GB 2R×8 PC2-5300U-555-12-E0	2 Ranks, Non-ECC	512 Mbit (×8)
HYS64T128920HU-3S-A	1GB 2R×8 PC2-5300U-555-12-E0	2 Ranks, Non-ECC	512 Mbit (×8)
HYS72T128020HU-3S-A	1GB 2R×8 PC2-5300E-555-12-G0	2 Ranks, ECC	512 Mbit (×8)
PC2-4200			
HYS64T32000HU-3.7-A	256MB 1R×16 PC2-4200U-444-11-C1	1 Rank, Non-ECC	512 Mbit (×16)
HYS64T32900HU-3.7-A	256MB 1R×16 PC2-4200U-444-11-C1	1 Rank, Non-ECC	512 Mbit (×16)
HYS64T64000HU-3.7-A	512MB 1R×8 PC2-4200U-444-11-A1	1 Rank, Non-ECC	512 Mbit (×8)
HYS64T64900HU-3.7-A	512MB 1R×8 PC2-4200U-444-11-D0	1 Rank, Non-ECC	512 Mbit (×8)
HYS72T64000HU-3.7-A	512MB 1R×8 PC2-4200E-444-11-A1	1 Rank, ECC	512 Mbit (×8)
HYS64T128020HU-3.7-A	1GB 2R×8 PC2-4200U-444-11-B1	2 Ranks, Non-ECC	512 Mbit (×8)
HYS64T128920HU-3.7-A	1GB 2R×8 PC2-4200U-444-11-E0	2 Ranks, Non-ECC	512 Mbit (×8)
HYS72T128020HU-3.7-A	1GB 2R×8 PC2-4200E-444-11-B1	2 Ranks, ECC	512 Mbit (×8)
PC2-3200			
HYS64T32000HU-5-A	256MB 1R×16 PC2-3200U-333-11-C1	1 Rank, Non-ECC	512 Mbit (×16)
HYS64T64000HU-5-A	512MB 1R×8 PC2-3200U-333-11-A1	1 Rank, Non-ECC	512 Mbit (×8)
HYS72T64000HU-5-A	512MB 1R×8 PC2-3200E-333-11-A1	1 Rank, ECC	512 Mbit (×8)

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Product Type ¹⁾	Compliance Code ²⁾	Description	SDRAM Technology
HYS64T128020HU-5-A	1GB 2R×8 PC2-3200U-333-11-B1	2 Ranks, Non-ECC	512 Mbit (×8)
HYS72T128020HU-5-A	1GB 2R×8 PC2-3200E-333-12-B1	2 Ranks, ECC	512 Mbit (×8)

- 1) All product types end with a place code, designating the silicon die revision. Example: HYS64T64000HU-3-A, indicating Rev. "A" dies are used for DDR2 SDRAM components. For all Qimonda DDR2 module and component nomenclature see **Chapter 6** of this data sheet.
- 2) The Compliance Code is printed on the module label and describes the speed grade, for example "PC2-5300U-444-12-C1", where 4200U means Unbuffered DIMM modules with 4.26 GB/sec Module Bandwidth and "444-12" means Column Address Strobe (CAS) latency = 4, Row Column Delay (RCD) latency = 4 and Row Precharge (RP) latency = 4 using the latest JEDEC SPD Revision 1.2 and produced on the Raw Card "C".

TABLE 5
Address Format

DIMM Density	Module Organization	Memory Ranks	ECC/ Non-ECC	# of SDRAMs	# of row/bank/column bits	Raw Card
256 MByte	32M ×64	1	Non-ECC	4	13/2/10	C
512 MByte	64M ×64	1	Non-ECC	8	14/2/10	A,D
512 MByte	64M ×72	1	ECC	9	14/2/10	A,F
1 GByte	128M ×64	2	Non-ECC	16	14/2/10	B,E
1 GByte	128M ×72	2	ECC	18	14/2/10	B,G

TABLE 6
Components on Modules

Product Type ¹⁾	DRAM Components ¹⁾	DRAM Density	DRAM Organisation	Notes ²⁾
HYS64T32000HU	HYB18T512160AF	512 Mbit	32M × 16	
HYS64T32900HU	HYB18T512160AF	512 Mbit	32M × 16	
HYS64T64000HU	HYB18T512800AF	512 Mbit	64M × 8	
HYS64T64900HU	HYB18T512800AF	512 Mbit	64M × 8	
HYS72T64000HU	HYB18T512800AF	512 Mbit	64M × 8	
HYS64T128020HU	HYB18T512800AF	512 Mbit	64M × 8	
HYS64T128920HU	HYB18T512800AF	512 Mbit	64M × 8	
HYS72T128020HU	HYB18T512800AF	512 Mbit	64M × 8	

- 1) Green Product
- 2) For a detailed description of all functionalities of the DRAM components on these modules see the component data sheet.

2 Pin Configurations

This chapter contains information to the pin configuration of the modules as well as the block diagrams to the various module organization

The pin configuration of the Unbuffered DDR2 SDRAM DIMM is listed by function in **Table 7** (240 pins). The abbreviations used in columns Pin and Buffer Type are explained in **Table 8** and **Table 9** respectively. The pin numbering is depicted in **Figure 1** for non-ECC modules (×64) and **Figure 2** for ECC modules (×72).

TABLE 7
Pin Configuration of UDIMM

Ball No.	Name	Pin Type	Buffer Type	Function
Clock Signals				
185	CK0	I	SSTL	Clock Signals 2:0, Complement Clock Signals 2:0
137	CK1	I	SSTL	
220	CK2	I	SSTL	
186	CK0	I	SSTL	
138	CK1	I	SSTL	
221	CK2	I	SSTL	
52	CKE0	I	SSTL	Clock Enable Rank 1:0
171	CKE1	I	SSTL	Not Connected <i>Note: 1 Rank module</i>
	NC	NC	—	
Control Signals				
193	S0#	I	SSTL	Chip Select Rank 1:0
76	S1#	I	SSTL	
	NC	NC	—	Not Connected <i>Note: 1 Rank module</i>
192	RAS	I	SSTL	Row Address Strobe
74	$\overline{\text{CAS}}$	I	SSTL	Column Address Strobe
73	$\overline{\text{WE}}$	I	SSTL	Write Enable
Address Signals				
71	BA0	I	SSTL	Bank Address Bus 1:0
190	BA1	I	SSTL	
54	BA2	I	SSTL	Bank Address Bus 2
	NC	NC	—	Not Connected Less than 1Gb DDR2 SDRAMS

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Ball No.	Name	Pin Type	Buffer Type	Function
188	A0	I	SSTL	Address Bus 12:0
183	A1	I	SSTL	
63	A2	I	SSTL	
182	A3	I	SSTL	
61	A4	I	SSTL	
60	A5	I	SSTL	
180	A6	I	SSTL	
58	A7	I	SSTL	
179	A8	I	SSTL	
177	A9	I	SSTL	
70	A10	I	SSTL	
	AP	I	SSTL	
57	A11	I	SSTL	
176	A12	I	SSTL	
196	A13	I	SSTL	Address Signal 13 <i>Note: 1 Gbit based module and 512M x4/x8</i>
	NC	NC	—	Not Connected <i>Note: Module based on 1 Gbit x16 Module based on 512 Mbit x16 or smaller</i>
174	A14	I	SSTL	Address Signal 14 <i>Note: Modules based on 2 Gbit</i>
	NC	NC	—	Not Connected <i>Note: Modules based on 1 Gbit or smaller</i>
Data Signals				
3	DQ0	I/O	SSTL	Data Bus 63:0 Data Input/Output pins
4	DQ1	I/O	SSTL	
9	DQ2	I/O	SSTL	
10	DQ3	I/O	SSTL	
122	DQ4	I/O	SSTL	
123	DQ5	I/O	SSTL	
128	DQ6	I/O	SSTL	
129	DQ7	I/O	SSTL	

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Ball No.	Name	Pin Type	Buffer Type	Function
12	DQ8	I/O	SSTL	Data Bus 63:0 Data Input/Output pins
13	DQ9	I/O	SSTL	
21	DQ10	I/O	SSTL	
22	DQ11	I/O	SSTL	
131	DQ12	I/O	SSTL	
132	DQ13	I/O	SSTL	
140	DQ14	I/O	SSTL	
141	DQ15	I/O	SSTL	
24	DQ16	I/O	SSTL	
25	DQ17	I/O	SSTL	
30	DQ18	I/O	SSTL	
31	DQ19	I/O	SSTL	
143	DQ20	I/O	SSTL	
144	DQ21	I/O	SSTL	
149	DQ22	I/O	SSTL	
150	DQ23	I/O	SSTL	
33	DQ24	I/O	SSTL	
34	DQ25	I/O	SSTL	
39	DQ26	I/O	SSTL	
40	DQ27	I/O	SSTL	
152	DQ28	I/O	SSTL	
153	DQ29	I/O	SSTL	
158	DQ30	I/O	SSTL	
159	DQ31	I/O	SSTL	
80	DQ32	I/O	SSTL	
81	DQ33	I/O	SSTL	
86	DQ34	I/O	SSTL	
87	DQ35	I/O	SSTL	
199	DQ36	I/O	SSTL	
200	DQ37	I/O	SSTL	
205	DQ38	I/O	SSTL	
206	DQ39	I/O	SSTL	
89	DQ40	I/O	SSTL	
90	DQ41	I/O	SSTL	
95	DQ42	I/O	SSTL	
96	DQ43	I/O	SSTL	
208	DQ44	I/O	SSTL	
209	DQ45	I/O	SSTL	
214	DQ46	I/O	SSTL	
215	DQ47	I/O	SSTL	

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Ball No.	Name	Pin Type	Buffer Type	Function
98	DQ48	I/O	SSTL	Data Bus 63:0 Data Input/Output pins
99	DQ49	I/O	SSTL	
107	DQ50	I/O	SSTL	
108	DQ51	I/O	SSTL	
217	DQ52	I/O	SSTL	
218	DQ53	I/O	SSTL	
226	DQ54	I/O	SSTL	
227	DQ55	I/O	SSTL	
110	DQ56	I/O	SSTL	
111	DQ57	I/O	SSTL	
116	DQ58	I/O	SSTL	
117	DQ59	I/O	SSTL	
229	DQ60	I/O	SSTL	
230	DQ61	I/O	SSTL	
235	DQ62	I/O	SSTL	
236	DQ63	I/O	SSTL	
Check Bit Signals				
42	CB0	I/O	SSTL	Check Bit 0 <i>Note: ECC type module only</i>
	NC	NC	—	Not Connected <i>Note: ECC type module only</i>
43	CB1	I/O	SSTL	Check Bit 1 <i>Note: ECC type module only</i>
	NC	NC	—	Not Connected <i>Note: ECC type module only</i>
48	CB2	I/O	SSTL	Check Bit 2 <i>Note: ECC type module only</i>
	NC	NC	—	Not Connected <i>Note: ECC type module only</i>
49	CB3	I/O	SSTL	Check Bit 3 <i>Note: ECC type module only</i>
	NC	NC	—	Not Connected <i>Note: ECC type module only</i>
161	CB4	I/O	SSTL	Check Bit 4 <i>Note: ECC type module only</i>
	NC	NC	—	Not Connected <i>Note: ECC type module only</i>
162	CB5	I/O	SSTL	Check Bit 5 <i>Note: ECC type module only</i>
	NC	NC	—	Not Connected <i>Note: ECC type module only</i>

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Ball No.	Name	Pin Type	Buffer Type	Function
167	CB6	I/O	SSTL	Check Bit 6 <i>Note: ECC type module only</i>
	NC	NC	—	Not Connected <i>Note: ECC type module only</i>
168	CB7	I/O	SSTL	Check Bit 7 <i>Note: ECC type module only</i>
	NC	NC	—	Not Connected <i>Note: Non-ECC module</i>
Data Strobe Bus				
7	DQS0	I/O	SSTL	Data Strobe Bus 8:0
16	DQS1	I/O	SSTL	
28	DQS2	I/O	SSTL	
37	DQS3	I/O	SSTL	
84	DQS4	I/O	SSTL	
93	DQS5	I/O	SSTL	
105	DQS6	I/O	SSTL	
114	DQS7	I/O	SSTL	
46	DQS8	I/O	SSTL	
6	$\overline{\text{DQS0}}$	I/O	SSTL	Complement Data Strobe Bus 8:0
15	$\overline{\text{DQS1}}$	I/O	SSTL	
27	$\overline{\text{DQS2}}$	I/O	SSTL	
36	$\overline{\text{DQS3}}$	I/O	SSTL	
83	$\overline{\text{DQS4}}$	I/O	SSTL	
92	$\overline{\text{DQS5}}$	I/O	SSTL	
104	$\overline{\text{DQS6}}$	I/O	SSTL	
113	$\overline{\text{DQS7}}$	I/O	SSTL	
45	$\overline{\text{DQS8}}$	I/O	SSTL	
Data Mask Signals				
125	DM0	I	SSTL	Data Mask Bus 8:0
134	DM1	I	SSTL	
146	DM2	I	SSTL	
155	DM3	I	SSTL	
202	DM4	I	SSTL	
211	DM5	I	SSTL	
223	DM6	I	SSTL	
232	DM7	I	SSTL	
164	DM8	I	SSTL	
EEPROM				
120	SCL	I	CMOS	Serial Bus Clock
119	SDA	I/O	OD	Serial Bus Data

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Ball No.	Name	Pin Type	Buffer Type	Function
239	SA0	I	CMOS	Serial Address Select Bus 2:0
240	SA1	I	CMOS	
101	SA2	I	CMOS	
Power Supplies				
1	V_{REF}	AI	—	I/O Reference Voltage
238	V_{DDSPD}	PWR	—	EEPROM Power Supply
51,56,62,72,75,, 78,170,175,181,, 191,194	V_{DDQ}	PWR	—	I/O Driver Power Supply
53,59,64,67,69,, 172,178,184,187, 189,197	V_{DD}	PWR	—	Power Supply
2,5,8,11,14,17,, 20,23,26,29,32, 35,38,41,44,47,, 50,65,66,79,82, 85,88,91,94,97,, 100,103,106, 109,112,115,118, 121,124,127,, 130,133,136,139, 142,145,148,, 151,154,157,160, 163,166,169, 198,201,204,207, 210,213,216,, 219,222,225,228, 231,234,237	V_{SS}	GND	—	Ground Plane
Other Pins				
195	ODT0	I	SSTL	On-Die Termination Control 0
77	ODT1	I	SSTL	On-Die Termination Control 1 <i>Note: 2 Rank modules</i>
	NC	NC	—	Not Connected <i>Note: 1 Rank modules</i>
18,19,55,68,102,1 26,135,147, 156,165,173,203, 212, 224,233	NC	NC	—	Not connected <i>Note: Pins not connected on Qimonda UDIMMs</i>

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

TABLE 8
Abbreviations for Pin Type

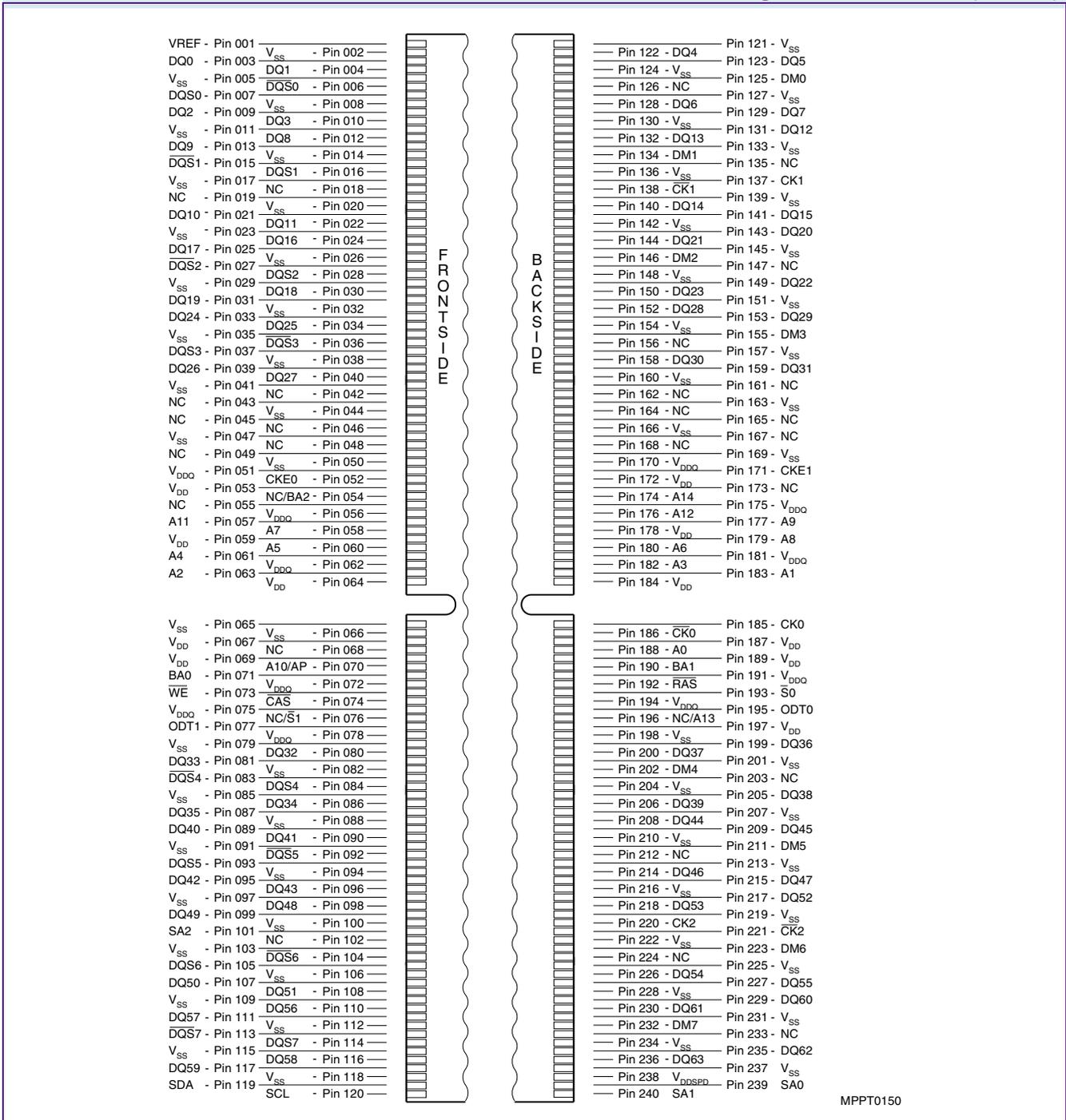
Abbreviation	Description
I	Standard input-only pin. Digital levels.
O	Output. Digital levels.
I/O	I/O is a bidirectional input/output signal.
AI	Input. Analog levels.
PWR	Power
GND	Ground
NC	Not Connected

TABLE 9
Abbreviations for Buffer Type

Abbreviation	Description
SSTL	Serial Stub Terminated Logic (SSTL_18)
LV-CMOS	Low Voltage CMOS
CMOS	CMOS Levels
OD	Open Drain. The corresponding pin has 2 operational states, active low and tri-state, and allows multiple devices to share as a wire-OR.

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
 Unbuffered DDR2 SDRAM Modules

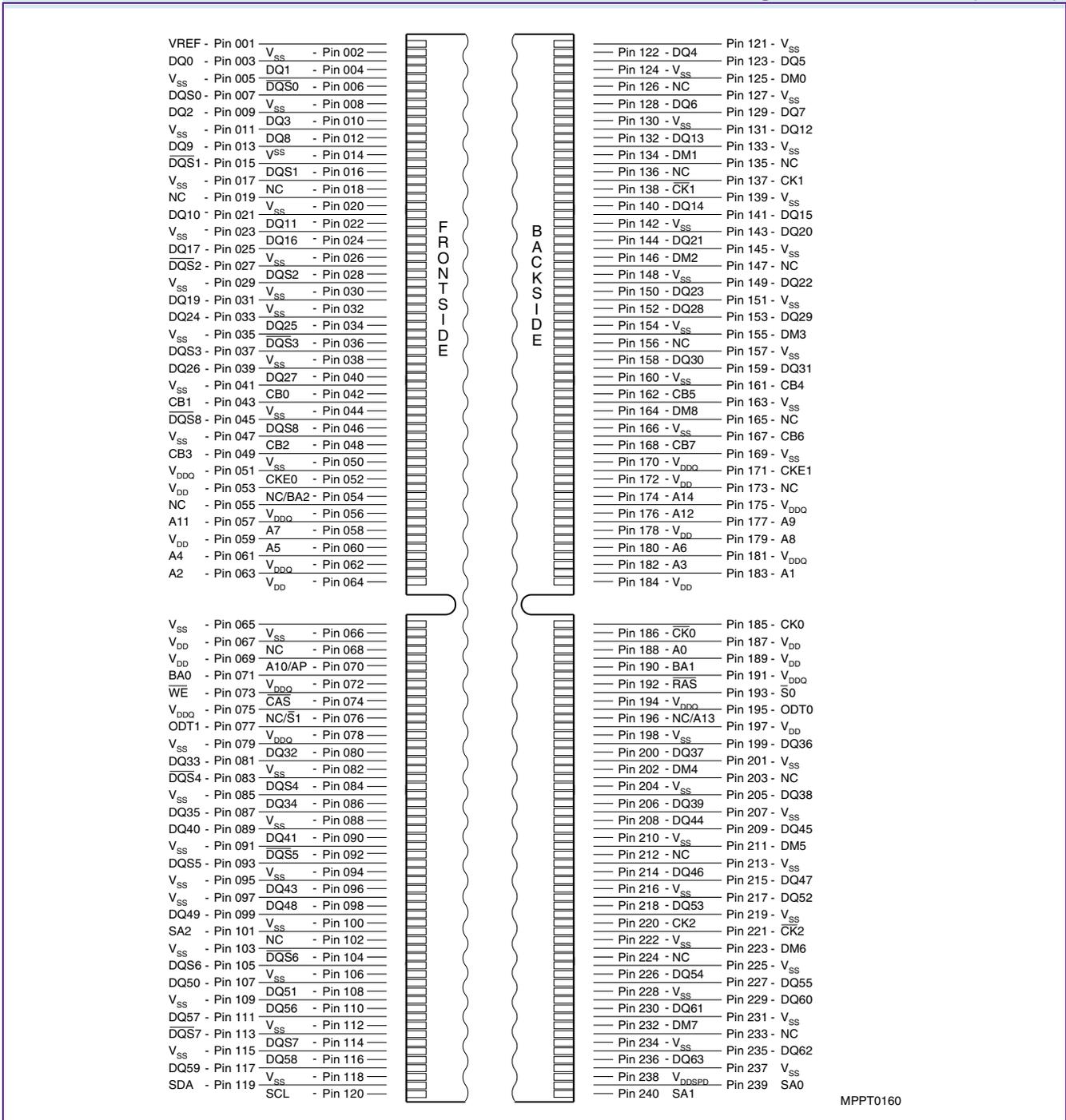
FIGURE 1
Pin Configuration UDIMM ×64 (240 Pin)



MPPT0150

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
 Unbuffered DDR2 SDRAM Modules

FIGURE 2
Pin Configuration UDIMM ×72 (240 Pin)



MPPT0160

3 Electrical Characteristics

This chapter contains the electrical characteristics.

3.1 Absolute Maximum Ratings

Caution is needed not to exceed absolute maximum ratings of the DRAM device listed in **Table 10** at any time.

TABLE 10
Absolute Maximum Ratings

Symbol	Parameter	Rating		Unit	Notes
		Min.	Max.		
V_{DD}	Voltage on V_{DD} pin relative to V_{SS}	-1.0	+2.3	V	1)
V_{DDQ}	Voltage on V_{DDQ} pin relative to V_{SS}	-0.5	+2.3	V	1)2)
V_{DDL}	Voltage on V_{DDL} pin relative to V_{SS}	-0.5	+2.3	V	1)2)
V_{IN}, V_{OUT}	Voltage on any pin relative to V_{SS}	-0.5	+2.3	V	1)
T_{STG}	Storage Temperature	-55	+100	°C	1)2)

- 1) When V_{DD} and V_{DDQ} and V_{DDL} are less than 500 mV; V_{REF} may be equal to or less than 300 mV.
- 2) Storage Temperature is the case surface temperature on the center/top side of the DRAM.

Attention: Stresses greater than those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

TABLE 11
DRAM Component Operating Temperature Range

Symbol	Parameter	Rating		Unit	Notes
		Min.	Max.		
T_{OPER}	Operating Temperature	0	95	°C	1)2)3)4)

- 1) Operating Temperature is the case surface temperature on the center / top side of the DRAM.
- 2) The operating temperature range are the temperatures where all DRAM specification will be supported. During operation, the DRAM case temperature must be maintained between 0 - 95 °C under all other specification parameters.
- 3) Above 85 °C the Auto-Refresh command interval has to be reduced to $t_{REFI} = 3.9 \mu s$
- 4) When operating this product in the 85 °C to 95 °C TCASE temperature range, the High Temperature Self Refresh has to be enabled by setting EMR(2) bit A7 to “1”. When the High Temperature Self Refresh is enabled there is an increase of I_{DD6} by approximately 50%

3.2 DC Operating Conditions

This chapter contains the DC operating conditions tables.

TABLE 12
Operating Conditions

Parameter	Symbol	Values		Unit	Notes
		Min.	Max.		
Operating temperature (ambient)	T_{OPR}	0	+65	°C	
DRAM Case Temperature	T_{CASE}	0	+95	°C	1)2)3)4)
Storage Temperature	T_{STG}	- 50	+100	°C	
Barometric Pressure (operating & storage)	PBar	+69	+105	kPa	5)
Operating Humidity (relative)	H_{OPR}	10	90	%	

- 1) DRAM Component Case Temperature is the surface temperature in the center on the top side of any of the DRAMs.
- 2) Within the DRAM Component Case Temperature Range all DRAM specifications will be supported
- 3) Above 85 °C DRAM Case Temperature the Auto-Refresh command interval has to be reduced to $t_{REF1} = 3.9 \mu s$
- 4) Self-Refresh period is hard-coded in the DRAMs and therefore it is imperative that the system ensures the DRAM is below 85 °C Case Temperature before initiating Self-Refresh operation.
- 5) Up to 3000 m.

TABLE 13
Supply Voltage Levels and DC Operating Conditions

Parameter	Symbol	Values			Unit	Notes
		Min.	Nom.	Max.		
Device Supply Voltage	V_{DD}	1.7	1.8	1.9	V	
Output Supply Voltage	V_{DDQ}	1.7	1.8	1.9	V	1)
Input Reference Voltage	V_{REF}	$0.49 \times V_{DDQ}$	$0.5 \times V_{DDQ}$	$0.51 \times V_{DDQ}$	V	2)
SPD Supply Voltage	V_{DDSPD}	1.7	—	3.6	V	
DC Input Logic High	$V_{IH(DC)}$	$V_{REF} + 0.125$	—	$V_{DDQ} + 0.3$	V	
DC Input Logic Low	$V_{IL(DC)}$	- 0.30	—	$V_{REF} - 0.125$	V	
In / Output Leakage Current	I_L	- 5	—	5	μA	3)

- 1) Under all conditions, V_{DDQ} must be less than or equal to V_{DD}
- 2) Peak to peak AC noise on V_{REF} may not exceed $\pm 2\% V_{REF(DC)}$. V_{REF} is also expected to track noise in V_{DDQ} .
- 3) Input voltage for any connector pin under test of $0 V \leq V_{IN} \leq V_{DDQ} + 0.3 V$; all other pins at 0 V. Current is per pin

3.3 AC Characteristics

This chapter contains the AC operating conditions tables.

3.3.1 Speed Grade Definitions

List of speed grade definition tables.

- Table 14 “Speed Grade Definition Speed Bins for DDR2-667” on Page 18
- Table 15 “Speed Grade Definition Speed Bins for DDR2-533C” on Page 19
- Table 16 “Speed Grade Definition Speed Bins for DDR2-400B” on Page 19

TABLE 14

Speed Grade Definition Speed Bins for DDR2-667

Speed Grade		DDR2-667C		DDR2-667D		Unit	Notes	
QAG Sort Name		-3		-3S				
CAS-RCD-RP latencies		4-4-4		5-5-5		t_{CK}		
Parameter	Symbol	Min.	Max.	Min.	Max.	—		
Clock Frequency	@ CL = 3	t_{CK}	5	8	5	8	ns	1)2)3)4)
	@ CL = 4	t_{CK}	3	8	3.75	8	ns	1)2)3)4)
	@ CL = 5	t_{CK}	3	8	3	8	ns	1)2)3)4)
Row Active Time	t_{RAS}	45	70000	45	70000	ns	1)2)3)4)5)	
Row Cycle Time	t_{RC}	57	—	60	—	ns	1)2)3)4)	
RAS-CAS-Delay	t_{RCD}	12	—	15	—	ns	1)2)3)4)	
Row Precharge Time	t_{RP}	12	—	15	—	ns	1)2)3)4)	

- 1) Timings are guaranteed with CK/ \overline{CK} differential Slew Rate of 2.0 V/ns. For DQS signals timings are guaranteed with a differential Slew Rate of 2.0 V/ns in differential strobe mode and a Slew Rate of 1 V/ns in single ended mode. Timings are further guaranteed for normal OCD drive strength (EMRS(1) A1 = 0).
- 2) The CK/ \overline{CK} input reference level (for timing reference to CK/ \overline{CK}) is the point at which CK and \overline{CK} cross. The DQS / \overline{DQS} , RDQS / \overline{RDQS} , input reference level is the crosspoint when in differential strobe mode
- 3) Inputs are not recognized as valid until V_{REF} stabilizes. During the period before V_{REF} stabilizes, CKE = 0.2 x V_{DDQ} is recognized as low.
- 4) The output timing reference voltage level is V_{TT} .
- 5) $t_{RAS,MAX}$ is calculated from the maximum amount of time a DDR2 device can operate without a refresh command which is equal to $9 \times t_{REFI}$.

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TABLE 15

Speed Grade Definition Speed Bins for DDR2-533C

Speed Grade		DDR2-533C		Unit	Note	
QAG Sort Name		-3.7				
CAS-RCD-RP latencies		4-4-4		t_{CK}		
Parameter	Symbol	Min.	Max.	—		
Clock Frequency	@ CL = 3	t_{CK}	5	8	ns	1)2)3)4)
	@ CL = 4	t_{CK}	3.75	8	ns	1)2)3)4)
	@ CL = 5	t_{CK}	3.75	8	ns	1)2)3)4)
Row Active Time	t_{RAS}	45	70000	ns	1)2)3)4)5)	
Row Cycle Time	t_{RC}	60	—	ns	1)2)3)4)	
RAS-CAS-Delay	t_{RCD}	15	—	ns	1)2)3)4)	
Row Precharge Time	t_{RP}	15	—	ns	1)2)3)4)	

- 1) Timings are guaranteed with CK/ \overline{CK} differential Slew Rate of 2.0 V/ns. For DQS signals timings are guaranteed with a differential Slew Rate of 2.0 V/ns in differential strobe mode and a Slew Rate of 1 V/ns in single ended mode. Timings are further guaranteed for normal OCD drive strength (EMRS(1) A1 = 0)
- 2) The CK/ \overline{CK} input reference level (for timing reference to CK/ \overline{CK}) is the point at which CK and \overline{CK} cross. The DQS / \overline{DQS} , RDQS / \overline{RDQS} , input reference level is the crosspoint when in differential strobe mode.
- 3) Inputs are not recognized as valid until V_{REF} stabilizes. During the period before V_{REF} stabilizes, CKE = 0.2 x V_{DDQ} is recognized as low.
- 4) The output timing reference voltage level is V_{TT} .
- 5) $t_{RAS,MAX}$ is calculated from the maximum amount of time a DDR2 device can operate without a refresh command which is equal to 9 x t_{REFI} .

TABLE 16

Speed Grade Definition Speed Bins for DDR2-400B

Speed Grade		DDR2-400B		Unit	Note	
QAG Sort Name		-5				
CAS-RCD-RP latencies		3-3-3		t_{CK}		
Parameter	Symbol	Min.	Max.	—		
Clock Frequency	@ CL = 3	t_{CK}	5	8	ns	1)2)3)4)
	@ CL = 4	t_{CK}	5	8	ns	1)2)3)4)
	@ CL = 5	t_{CK}	5	8	ns	1)2)3)4)
Row Active Time	t_{RAS}	40	70000	ns	1)2)3)4)5)	
Row Cycle Time	t_{RC}	55	—	ns	1)2)3)4)	
RAS-CAS-Delay	t_{RCD}	15	—	ns	1)2)3)4)	
Row Precharge Time	t_{RP}	15	—	ns	1)2)3)4)	

- 1) Timings are guaranteed with CK/ \overline{CK} differential Slew Rate of 2.0 V/ns. For DQS signals timings are guaranteed with a differential Slew Rate of 2.0 V/ns in differential strobe mode and a Slew Rate of 1 V/ns in single ended mode. Timings are further guaranteed for normal OCD drive strength (EMRS(1) A1 = 0)
- 2) The CK/ \overline{CK} input reference level (for timing reference to CK/ \overline{CK}) is the point at which CK and \overline{CK} cross. The DQS / \overline{DQS} , RDQS / \overline{RDQS} , input reference level is the crosspoint when in differential strobe mode.
- 3) Inputs are not recognized as valid until V_{REF} stabilizes. During the period before V_{REF} stabilizes, CKE = 0.2 x V_{DDQ} is recognized as low.
- 4) The output timing reference voltage level is V_{TT} .
- 5) $t_{RAS,MAX}$ is calculated from the maximum amount of time a DDR2 device can operate without a refresh command which is equal to 9 x t_{REFI} .

3.3.2 AC Timing Parameters

List of AC Timing parameters.

- Table 17 “Timing Parameter by Speed Grade - DDR2-667” on Page 20
- Table 18 “Timing Parameter by Speed Grade - DDR2-533” on Page 25
- Table 19 “Timing Parameter by Speed Grade - DDR2-400” on Page 28

TABLE 17

Timing Parameter by Speed Grade - DDR2-667

Parameter	Symbol	DDR2-667		Unit	Notes ¹⁾²⁾³⁾⁴⁾⁵⁾⁶⁾⁷⁾⁸⁾
		Min.	Max.		
DQ output access time from CK / $\overline{\text{CK}}$	t_{AC}	-450	+450	ps	9)
DQS output access time from CK / $\overline{\text{CK}}$	$t_{DQ\text{SCK}}$	-400	+400	ps	9)
Average clock high pulse width	$t_{CH.AVG}$	0.48	0.52	$t_{CK.AVG}$	10)11)
Average clock low pulse width	$t_{CL.AVG}$	0.48	0.52	$t_{CK.AVG}$	10)11)
Average clock period	$t_{CK.AVG}$	3000	8000	ps	
DQ and DM input setup time	$t_{DS.BASE}$	100	—	ps	12)13)14)
DQ and DM input hold time	$t_{DH.BASE}$	175	—	ps	13)14)15)
Control & address input pulse width for each input	t_{IPW}	0.6	—	$t_{CK.AVG}$	
DQ and DM input pulse width for each input	t_{DIPW}	0.35	—	$t_{CK.AVG}$	
Data-out high-impedance time from CK / $\overline{\text{CK}}$	t_{HZ}	—	$t_{AC.MAX}$	ps	9)16)
DQS/DQS low-impedance time from CK / $\overline{\text{CK}}$	$t_{LZ.DQS}$	$t_{AC.MIN}$	$t_{AC.MAX}$	ps	9)16)
DQ low impedance time from CK/ $\overline{\text{CK}}$	$t_{LZ.DQ}$	$2 \times t_{AC.MIN}$	$t_{AC.MAX}$	ps	9)16)
DQS-DQ skew for DQS & associated DQ signals	t_{DQSQ}	—	240	ps	17)
CK half pulse width	t_{HP}	$\text{Min}(t_{CH.ABS}, t_{CL.ABS})$	—	ps	18)
DQ hold skew factor	t_{QHS}	—	340	ps	19)
DQ/DQS output hold time from DQS	t_{QH}	$t_{HP} - t_{QHS}$	—	ps	20)
Write command to DQS associated clock edges	WL	RL-1		nCK	
DQS latching rising transition to associated clock edges	t_{DQSS}	- 0.25	+ 0.25	$t_{CK.AVG}$	21)
DQS input high pulse width	t_{DQSH}	0.35	—	$t_{CK.AVG}$	
DQS input low pulse width	t_{DQSL}	0.35	—	$t_{CK.AVG}$	
DQS falling edge to CK setup time	t_{DSS}	0.2	—	$t_{CK.AVG}$	21)
DQS falling edge hold time from CK	t_{DSH}	0.2	—	$t_{CK.AVG}$	21)
Write postamble	t_{WPST}	0.4	0.6	$t_{CK.AVG}$	
Write preamble	t_{WPRE}	0.35	—	$t_{CK.AVG}$	
Address and control input setup time	$t_{LS.BASE}$	200	—	ps	22)23)
Address and control input hold time	$t_{LH.BASE}$	275	—	ps	23)24)
Read preamble	t_{RPRE}	0.9	1.1	$t_{CK.AVG}$	25)26)
Read postamble	t_{RPST}	0.4	0.6	$t_{CK.AVG}$	25)27)
Active to precharge command	t_{RAS}	45	70000	ns	28)

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Parameter	Symbol	DDR2-667		Unit	Notes ¹⁾²⁾³⁾⁴⁾⁵⁾⁶⁾⁷⁾⁸⁾
		Min.	Max.		
Active to active command period for 1KB page size products	t_{RRD}	7.5	—	ns	28)
Active to active command period for 2KB page size products	t_{RRD}	10	—	ns	28)
Four Activate Window for 1KB page size products	t_{FAW}	37.5	—	ns	28)
Four Activate Window for 2KB page size products	t_{FAW}	50	—	ns	28)
CAS to CAS command delay	t_{CCD}	2	—	nCK	
Write recovery time	t_{WR}	15	—	ns	28)
Auto-Precharge write recovery + precharge time	t_{DAL}	$WR + t_{nRP}$	—	nCK	29)30)
Internal write to read command delay	t_{WTR}	7.5	—	ns	28)31)
Internal Read to Precharge command delay	t_{RTP}	7.5	—	ns	28)
Exit self-refresh to a non-read command	t_{XSNR}	$t_{RFC} + 10$	—	ns	28)
Exit self-refresh to read command	t_{XSRD}	200	—	nCK	
Exit precharge power-down to any valid command (other than NOP or Deselect)	t_{XP}	2	—	nCK	
Exit power down to read command	t_{XARD}	2	—	nCK	
Exit active power-down mode to read command (slow exit, lower power)	t_{XARDS}	7 – AL	—	nCK	
CKE minimum pulse width (high and low pulse width)	t_{CKE}	3	—	nCK	32)
ODT turn-on delay	t_{AOND}	2	2	nCK	
ODT turn-on	t_{AON}	$t_{AC,MIN}$	$t_{AC,MAX} + 0.7$	ns	9)33)
ODT turn-on (Power down mode)	t_{AONPD}	$t_{AC,MIN} + 2$	$2 \times t_{CK,AVG} + t_{AC,MAX} + 1$	ns	
ODT turn-off delay	t_{AOFD}	2.5	2.5	nCK	
ODT turn-off	t_{AOF}	$t_{AC,MIN}$	$t_{AC,MAX} + 0.6$	ns	34)35)
ODT turn-off (Power down mode)	t_{AOFPD}	$t_{AC,MIN} + 2$	$2.5 \times t_{CK,AVG} + t_{AC,MAX} + 1$	ns	
ODT to power down entry latency	t_{ANPD}	3	—	nCK	
ODT to power down exit latency	t_{AXPD}	8	—	nCK	
Mode register set command cycle time	t_{MRD}	2	—	nCK	
MRS command to ODT update delay	t_{MOD}	0	12	ns	1)
OCD drive mode output delay	t_{OIT}	0	12	ns	1)
Minimum time clocks remain ON after CKE asynchronously drops LOW	t_{DELAY}	$t_{LS} + t_{CK,AVG} + t_{LH}$	—	ns	

- 1) For details and notes see the relevant Qimonda component data sheet
- 2) $V_{DDQ} = 1.8 V \pm 0.1 V$; $V_{DD} = 1.8 V \pm 0.1 V$. See notes⁵⁾⁶⁾⁷⁾⁸⁾
- 3) Timing that is not specified is illegal and after such an event, in order to guarantee proper operation, the DRAM must be powered down and then restarted through the specified initialization sequence before normal operation can continue.
- 4) Timings are guaranteed with $\overline{CK}/\overline{CK}$ differential Slew Rate of 2.0 V/ns. For DQS signals timings are guaranteed with a differential Slew Rate of 2.0 V/ns in differential strobe mode and a Slew Rate of 1 V/ns in single ended mode.
- 5) The $\overline{CK} / \overline{CK}$ input reference level (for timing reference to $\overline{CK} / \overline{CK}$) is the point at which \overline{CK} and \overline{CK} cross. The $\overline{DQS} / \overline{DQS}$, $\overline{RDQS} / \overline{RDQS}$, input reference level is the crosspoint when in differential strobe mode.

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- 6) Inputs are not recognized as valid until V_{REF} stabilizes. During the period before V_{REF} stabilizes, $CKE = 0.2 \times V_{DDQ}$ is recognized as low.
- 7) The output timing reference voltage level is V_{TT} .
- 8) New units, ' $t_{CK,AVG}$ ' and ' nCK ', are introduced in DDR2-667 and DDR2-800. Unit ' $t_{CK,AVG}$ ' represents the actual $t_{CK,AVG}$ of the input clock under operation. Unit ' nCK ' represents one clock cycle of the input clock, counting the actual clock edges. Note that in DDR2-400 and DDR2-533, ' t_{CK} ' is used for both concepts. Example: $t_{XP} = 2 [nCK]$ means; if Power Down exit is registered at T_m , an Active command may be registered at $T_m + 2$, even if $(T_m + 2 - T_m)$ is $2 \times t_{CK,AVG} + t_{ERR,2PER(MIN)}$.
- 9) When the device is operated with input clock jitter, this parameter needs to be derated by the actual $t_{ERR(6-10PER)}$ of the input clock. (output deratings are relative to the SDRAM input clock.) For example, if the measured jitter into a DDR2-667 SDRAM has $t_{ERR(6-10PER),MIN} = -272$ ps and $t_{ERR(6-10PER),MAX} = +293$ ps, then $t_{DQSCK,MIN(DERATED)} = t_{DQSCK,MIN} - t_{ERR(6-10PER),MAX} = -400$ ps $- 293$ ps = -693 ps and $t_{DQSCK,MAX(DERATED)} = t_{DQSCK,MAX} - t_{ERR(6-10PER),MIN} = 400$ ps $+ 272$ ps = $+672$ ps. Similarly, $t_{LZ,DQ}$ for DDR2-667 derates to $t_{LZ,DQ,MIN(DERATED)} = -900$ ps $- 293$ ps = -1193 ps and $t_{LZ,DQ,MAX(DERATED)} = 450$ ps $+ 272$ ps = $+722$ ps. (Caution on the MIN/MAX usage!)
- 10) Input clock jitter spec parameter. These parameters are referred to as 'input clock jitter spec parameters' and these parameters apply to DDR2-667 and DDR2-800 only. The jitter specified is a random jitter meeting a Gaussian distribution.
- 11) These parameters are specified per their average values, however it is understood that the relationship between the average timing and the absolute instantaneous timing holds all the times (min. and max of SPEC values are to be used for calculations).
- 12) Input waveform timing t_{DS} with differential data strobe enabled MR[bit10] = 0, is referenced from the input signal crossing at the $V_{IH,AC}$ level to the differential data strobe crosspoint for a rising signal, and from the input signal crossing at the $V_{IL,AC}$ level to the differential data strobe crosspoint for a falling signal applied to the device under test. DQS, DQS signals must be monotonic between $V_{i(DC),MAX}$ and $V_{i(DC),MIN}$. See **Figure 4**.
- 13) If t_{DS} or t_{DH} is violated, data corruption may occur and the data must be re-written with valid data before a valid READ can be executed.
- 14) These parameters are measured from a data signal ((L/U)DM, (L/U)DQ0, (L/U)DQ1, etc.) transition edge to its respective data strobe signal ((L/U/R)DQS / \overline{DQS}) crossing.
- 15) Input waveform timing t_{DH} with differential data strobe enabled MR[bit10] = 0, is referenced from the differential data strobe crosspoint to the input signal crossing at the $V_{IH,DC}$ level for a falling signal and from the differential data strobe crosspoint to the input signal crossing at the $V_{IL,DC}$ level for a rising signal applied to the device under test. DQS, DQS signals must be monotonic between $V_{IL,DC,MAX}$ and $V_{IH,DC,MIN}$. See **Figure 4**.
- 16) t_{HZ} and t_{LZ} transitions occur in the same access time as valid data transitions. These parameters are referenced to a specific voltage level which specifies when the device output is no longer driving (t_{HZ}), or begins driving (t_{LZ}).
- 17) t_{DQSQ} : Consists of data pin skew and output pattern effects, and p-channel to n-channel variation of the output drivers as well as output slew rate mismatch between DQS / \overline{DQS} and associated DQ in any given cycle.
- 18) t_{HP} is the minimum of the absolute half period of the actual input clock. t_{HP} is an input parameter but not an input specification parameter. It is used in conjunction with t_{QHS} to derive the DRAM output timing t_{QH} . The value to be used for t_{QH} calculation is determined by the following equation; $t_{HP} = \text{MIN}(t_{CH,ABS}, t_{CL,ABS})$, where, $t_{CH,ABS}$ is the minimum of the actual instantaneous clock high time; $t_{CL,ABS}$ is the minimum of the actual instantaneous clock low time.
- 19) t_{QHS} accounts for: 1) The pulse duration distortion of on-chip clock circuits, which represents how well the actual t_{HP} at the input is transferred to the output; and 2) The worst case push-out of DQS on one transition followed by the worst case pull-in of DQ on the next transition, both of which are independent of each other, due to data pin skew, output pattern effects, and pchannel to n-channel variation of the output drivers.
- 20) $t_{QH} = t_{HP} - t_{QHS}$, where: t_{HP} is the minimum of the absolute half period of the actual input clock; and t_{QHS} is the specification value under the max column. {The less half-pulse width distortion present, the larger the t_{QH} value is; and the larger the valid data eye will be.} Examples: 1) If the system provides t_{HP} of 1315 ps into a DDR2-667 SDRAM, the DRAM provides t_{QH} of 975 ps minimum. 2) If the system provides t_{HP} of 1420 ps into a DDR2-667 SDRAM, the DRAM provides t_{QH} of 1080 ps minimum.
- 21) These parameters are measured from a data strobe signal ((L/U/R)DQS / \overline{DQS}) crossing to its respective clock signal (CK / \overline{CK}) crossing. The spec values are not affected by the amount of clock jitter applied (i.e. $t_{JIT,PER}$, $t_{JIT,CC}$, etc.), as these are relative to the clock signal crossing. That is, these parameters should be met whether clock jitter is present or not.
- 22) Input waveform timing is referenced from the input signal crossing at the $V_{IH,AC}$ level for a rising signal and $V_{IL,AC}$ for a falling signal applied to the device under test. See **Figure 5**.
- 23) These parameters are measured from a command/address signal (CKE, CS, RAS, CAS, WE, ODT, BA0, A0, A1, etc.) transition edge to its respective clock signal (CK / \overline{CK}) crossing. The spec values are not affected by the amount of clock jitter applied (i.e. $t_{JIT,PER}$; $t_{JIT,CC}$, etc.), as the setup and hold are relative to the clock signal crossing that latches the command/address. That is, these parameters should be met whether clock jitter is present or not.
- 24) Input waveform timing is referenced from the input signal crossing at the $V_{IL,DC}$ level for a rising signal and $V_{IH,DC}$ for a falling signal applied to the device under test. See **Figure 5**.
- 25) t_{RPST} end point and t_{RPRE} begin point are not referenced to a specific voltage level but specify when the device output is no longer driving (t_{RPST}), or begins driving (t_{RPRE}). **Figure 3** shows a method to calculate these points when the device is no longer driving (t_{RPST}), or begins driving (t_{RPRE}) by measuring the signal at two different voltages. The actual voltage measurement points are not critical as long as the calculation is consistent.

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- 26) When the device is operated with input clock jitter, this parameter needs to be derated by the actual $t_{\text{JIT.PER}}$ of the input clock. (output deratings are relative to the SDRAM input clock.) For example, if the measured jitter into a DDR2-667 SDRAM has $t_{\text{JIT.PER.MIN}} = -72$ ps and $t_{\text{JIT.PER.MAX}} = +93$ ps, then $t_{\text{RPRE.MIN(DERATED)}} = t_{\text{RPRE.MIN}} + t_{\text{JIT.PER.MIN}} = 0.9 \times t_{\text{CK.AVG}} - 72$ ps = + 2178 ps and $t_{\text{RPRE.MAX(DERATED)}} = t_{\text{RPRE.MAX}} + t_{\text{JIT.PER.MAX}} = 1.1 \times t_{\text{CK.AVG}} + 93$ ps = + 2843 ps. (Caution on the MIN/MAX usage!).
- 27) When the device is operated with input clock jitter, this parameter needs to be derated by the actual $t_{\text{JIT.DUTY}}$ of the input clock. (output deratings are relative to the SDRAM input clock.) For example, if the measured jitter into a DDR2-667 SDRAM has $t_{\text{JIT.DUTY.MIN}} = -72$ ps and $t_{\text{JIT.DUTY.MAX}} = +93$ ps, then $t_{\text{RPST.MIN(DERATED)}} = t_{\text{RPST.MIN}} + t_{\text{JIT.DUTY.MIN}} = 0.4 \times t_{\text{CK.AVG}} - 72$ ps = + 928 ps and $t_{\text{RPST.MAX(DERATED)}} = t_{\text{RPST.MAX}} + t_{\text{JIT.DUTY.MAX}} = 0.6 \times t_{\text{CK.AVG}} + 93$ ps = + 1592 ps. (Caution on the MIN/MAX usage!).
- 28) For these parameters, the DDR2 SDRAM device is characterized and verified to support $t_{\text{nPARAM}} = \text{RU}\{t_{\text{PARAM}} / t_{\text{CK.AVG}}\}$, which is in clock cycles, assuming all input clock jitter specifications are satisfied. For example, the device will support $t_{\text{nRP}} = \text{RU}\{t_{\text{RP}} / t_{\text{CK.AVG}}\}$, which is in clock cycles, if all input clock jitter specifications are met. This means: For DDR2-667 5-5-5, of which $t_{\text{RP}} = 15$ ns, the device will support $t_{\text{nRP}} = \text{RU}\{t_{\text{RP}} / t_{\text{CK.AVG}}\} = 5$, i.e. as long as the input clock jitter specifications are met, Precharge command at T_m and Active command at $T_m + 5$ is valid even if $(T_m + 5 - T_m)$ is less than 15 ns due to input clock jitter.
- 29) $\text{DAL} = \text{WR} + \text{RU}\{t_{\text{RP}}(\text{ns}) / t_{\text{CK}}(\text{ns})\}$, where RU stands for round up. WR refers to the tWR parameter stored in the MRS. For t_{RP} , if the result of the division is not already an integer, round up to the next highest integer. t_{CK} refers to the application clock period. Example: For DDR2-533 at $t_{\text{CK}} = 3.75$ ns with t_{WR} programmed to 4 clocks. $t_{\text{DAL}} = 4 + (15 \text{ ns} / 3.75 \text{ ns})$ clocks = 4 + (4) clocks = 8 clocks.
- 30) $t_{\text{DAL.nCK}} = \text{WR} [\text{nCK}] + t_{\text{nRP.nCK}} = \text{WR} + \text{RU}\{t_{\text{RP}} [\text{ps}] / t_{\text{CK.AVG}} [\text{ps}]\}$, where WR is the value programmed in the EMR.
- 31) t_{WTR} is at least two clocks ($2 \times t_{\text{CK}}$) independent of operation frequency.
- 32) $t_{\text{CKE.MIN}}$ of 3 clocks means CKE must be registered on three consecutive positive clock edges. CKE must remain at the valid input level the entire time it takes to achieve the 3 clocks of registration. Thus, after any CKE transition, CKE may not transition from its valid level during the time period of $t_{\text{IS}} + 2 \times t_{\text{CK}} + t_{\text{IH}}$.
- 33) ODT turn on time min is when the device leaves high impedance and ODT resistance begins to turn on. ODT turn on time max is when the ODT resistance is fully on. Both are measured from t_{AOND} .
- 34) ODT turn off time min is when the device starts to turn off ODT resistance. ODT turn off time max is when the bus is in high impedance. Both are measured from t_{AOFD} .
- 35) When the device is operated with input clock jitter, this parameter needs to be derated by $\{-t_{\text{JIT.DUTY.MAX}} - t_{\text{ERR(6-10PER).MAX}}\}$ and $\{-t_{\text{JIT.DUTY.MIN}} - t_{\text{ERR(6-10PER).MIN}}\}$ of the actual input clock. (output deratings are relative to the SDRAM input clock.) For example, if the measured jitter into a DDR2-667 SDRAM has $t_{\text{ERR(6-10PER).MIN}} = -272$ ps, $t_{\text{ERR(6-10PER).MAX}} = +293$ ps, $t_{\text{JIT.DUTY.MIN}} = -106$ ps and $t_{\text{JIT.DUTY.MAX}} = +94$ ps, then $t_{\text{AOF.MIN(DERATED)}} = t_{\text{AOF.MIN}} + \{-t_{\text{JIT.DUTY.MAX}} - t_{\text{ERR(6-10PER).MAX}}\} = -450$ ps + $\{-94 \text{ ps} - 293 \text{ ps}\} = -837$ ps and $t_{\text{AOF.MAX(DERATED)}} = t_{\text{AOF.MAX}} + \{-t_{\text{JIT.DUTY.MIN}} - t_{\text{ERR(6-10PER).MIN}}\} = 1050$ ps + $\{106 \text{ ps} + 272 \text{ ps}\} = +1428$ ps. (Caution on the MIN/MAX usage!).

FIGURE 3

Method for calculating transitions and endpoint

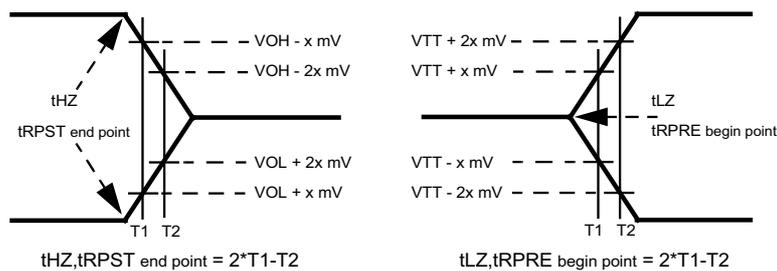


FIGURE 4

Differential input waveform timing - t_{DS} and t_{DH}

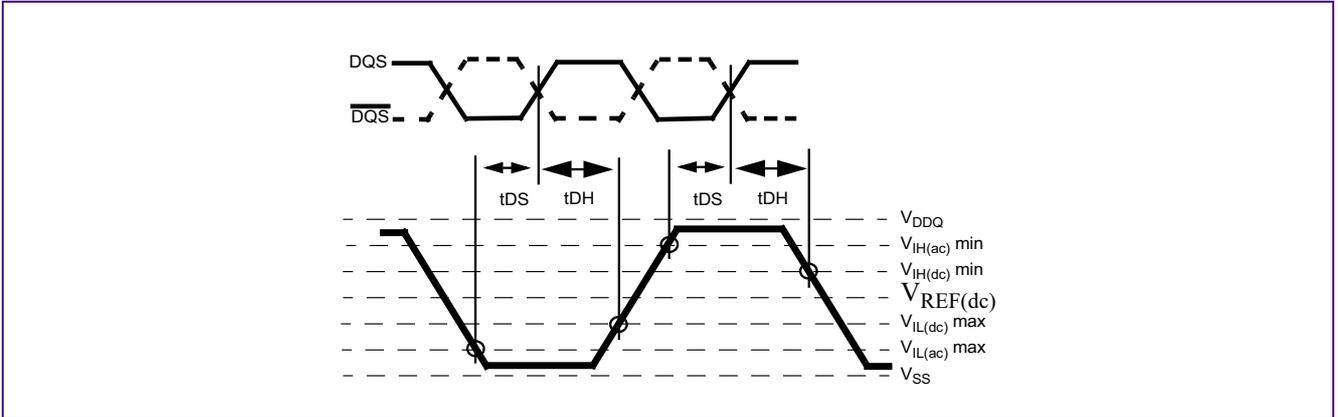
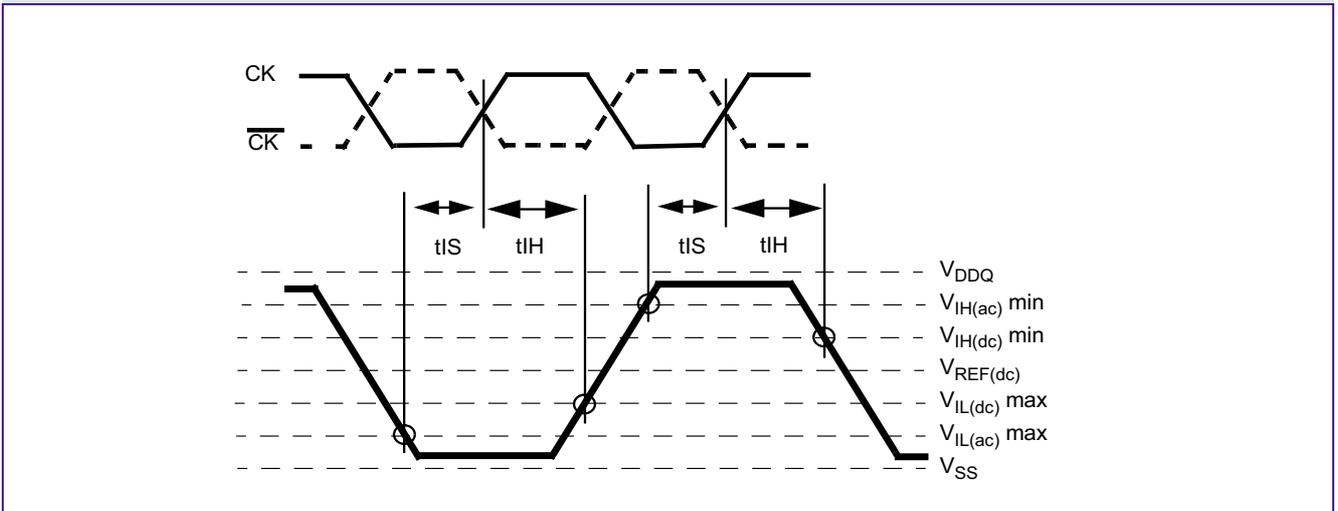


FIGURE 5

Differential input waveform timing - t_{IS} and t_{IH}



HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

TABLE 18
Timing Parameter by Speed Grade - DDR2-533

Parameter	Symbol	DDR2-533		Unit	Notes ¹⁾²⁾³⁾⁴⁾⁵⁾⁶⁾⁷⁾
		Min.	Max.		
DQ output access time from CK / $\overline{\text{CK}}$	t_{AC}	-500	+500	ps	
CAS A to $\overline{\text{CAS}}$ B command period	t_{CCD}	2	—	t_{CK}	
CK, $\overline{\text{CK}}$ high-level width	t_{CH}	0.45	0.55	t_{CK}	
CKE minimum high and low pulse width	t_{CKE}	3	—	t_{CK}	
CK, $\overline{\text{CK}}$ low-level width	t_{CL}	0.45	0.55	t_{CK}	
Auto-Precharge write recovery + precharge time	t_{DAL}	WR + t_{RP}	—	t_{CK}	8)18)
Minimum time clocks remain ON after CKE asynchronously drops LOW	t_{DELAY}	$t_{IS} + t_{CK} + t_{IH}$	—	ns	9)
DQ and DM input hold time (differential data strobe)	$t_{DH}(\text{base})$	225	—	ps	10)
DQ and DM input hold time (single ended data strobe)	$t_{DH1}(\text{base})$	-25	—	ps	11)
DQ and DM input pulse width (each input)	t_{DIPW}	0.35	—	t_{CK}	
DQS output access time from CK / $\overline{\text{CK}}$	t_{DQSCK}	-450	+450	ps	
DQS input low (high) pulse width (write cycle)	$t_{DQSL,H}$	0.35	—	t_{CK}	
DQS-DQ skew (for DQS & associated DQ signals)	t_{DQSQ}	—	300	ps	11)
Write command to 1st DQS latching transition	t_{DQSS}	- 0.25	+ 0.25	t_{CK}	
DQ and DM input setup time (differential data strobe)	$t_{DS}(\text{base})$	100	—	ps	11)
DQ and DM input setup time (single ended data strobe)	$t_{DS1}(\text{base})$	-25	—	ps	11)
DQS falling edge hold time from CK (write cycle)	t_{DSH}	0.2	—	t_{CK}	
DQS falling edge to CK setup time (write cycle)	t_{DSS}	0.2	—	t_{CK}	
Four Activate Window period	t_{FAW}	37.5	—	ns	13)
		50	—	ns	
Clock half period	t_{HP}	MIN. (t_{CL}, t_{CH})			12)
Data-out high-impedance time from CK / $\overline{\text{CK}}$	t_{HZ}	—	$t_{AC,MAX}$	ps	13)
Address and control input hold time	$t_{IH}(\text{base})$	375	—	ps	11)
Address and control input pulse width (each input)	t_{IPW}	0.6	—	t_{CK}	
Address and control input setup time	$t_{IS}(\text{base})$	250	—	ps	11)
DQ low-impedance time from CK / $\overline{\text{CK}}$	$t_{LZ(DQ)}$	$2 \times t_{AC,MIN}$	$t_{AC,MAX}$	ps	14)
DQS low-impedance from CK / $\overline{\text{CK}}$	$t_{LZ(DQS)}$	$t_{AC,MIN}$	$t_{AC,MAX}$	ps	14)
Mode register set command cycle time	t_{MRD}	2	—	t_{CK}	
OCD drive mode output delay	t_{OIT}	0	12	ns	
Data output hold time from DQS	t_{QH}	$t_{HP} - t_{QHS}$	—		

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Parameter	Symbol	DDR2-533		Unit	Notes ¹⁾²⁾³⁾⁴⁾⁵⁾⁶⁾⁷⁾
		Min.	Max.		
Data hold skew factor	t_{QHS}	—	400	ps	
Average periodic refresh Interval	t_{REFI}	—	7.8	μ S	14)15)
		—	3.9	μ S	16)18)
Auto-Refresh to Active/Auto-Refresh command period	t_{RFC}	105	—	ns	17)
Precharge-All (4 banks) command period	t_{RP}	$t_{RP} + 1t_{CK}$	—	ns	
Precharge-All (8 banks) command period	t_{RP}	$15 + 1t_{CK}$	—	ns	
Read preamble	t_{RPRE}	0.9	1.1	t_{CK}	14)
Read postamble	t_{RPST}	0.40	0.60	t_{CK}	14)
Active bank A to Active bank B command period	t_{RRD}	7.5	—	ns	14)18)
		10	—	ns	16)20)
Internal Read to Precharge command delay	t_{RTP}	7.5	—	ns	
Write preamble	t_{WPRE}	$0.25 \times t_{CK}$	—	t_{CK}	
Write postamble	t_{WPST}	0.40	0.60	t_{CK}	19)
Write recovery time for write without Auto-Precharge	t_{WR}	15	—	ns	
Write recovery time for write with Auto-Precharge	WR	t_{WR}/t_{CK}		t_{CK}	20)
Internal Write to Read command delay	t_{WTR}	7.5	—	ns	21)
Exit power down to any valid command (other than NOP or Deselect)	t_{XARD}	2	—	t_{CK}	22)
Exit active power-down mode to Read command (slow exit, lower power)	t_{XARDS}	6 – AL	—	t_{CK}	22)
Exit precharge power-down to any valid command (other than NOP or Deselect)	t_{XP}	2	—	t_{CK}	
Exit Self-Refresh to non-Read command	t_{XSNR}	$t_{RFC} + 10$	—	ns	
Exit Self-Refresh to Read command	t_{XSRD}	200	—	t_{CK}	

- 1) For details and notes see the relevant Qimonda component data sheet
- 2) $V_{DDQ} = 1.8 \text{ V} \pm 0.1 \text{ V}$; $V_{DD} = 1.8 \text{ V} \pm 0.1 \text{ V}$. See notes ⁵⁾⁶⁾⁷⁾⁸⁾
- 3) Timing that is not specified is illegal and after such an event, in order to guarantee proper operation, the DRAM must be powered down and then restarted through the specified initialization sequence before normal operation can continue.
- 4) Timings are guaranteed with $\overline{CK}/\overline{CK}$ differential Slew Rate of 2.0 V/ns. For DQS signals timings are guaranteed with a differential Slew Rate of 2.0 V/ns in differential strobe mode and a Slew Rate of 1 V/ns in single ended mode.
- 5) The $\overline{CK} / \overline{CK}$ input reference level (for timing reference to $\overline{CK} / \overline{CK}$) is the point at which \overline{CK} and \overline{CK} cross. The $\overline{DQS} / \overline{DQS}$, $\overline{RDQS} / \overline{RDQS}$, input reference level is the crosspoint when in differential strobe mode.
- 6) Inputs are not recognized as valid until V_{REF} stabilizes. During the period before V_{REF} stabilizes, $\overline{CKE} = 0.2 \times V_{DDQ}$ is recognized as low.
- 7) The output timing reference voltage level is V_{TT} .
- 8) For each of the terms, if not already an integer, round to the next highest integer. t_{CK} refers to the application clock period. WR refers to the WR parameter stored in the MR.
- 9) The clock frequency is allowed to change during self-refresh mode or precharge power-down mode.
- 10) For timing definition, refer to the Component data sheet.
- 11) Consists of data pin skew and output pattern effects, and p-channel to n-channel variation of the output drivers as well as output Slew Rate mis-match between $\overline{DQS} / \overline{DQS}$ and associated \overline{DQ} in any given cycle.
- 12) MIN (t_{CL} , t_{CH}) refers to the smaller of the actual clock low time and the actual clock high time as provided to the device (i.e. this value can be greater than the minimum specification limits for t_{CL} and t_{CH}).

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

- 13) The t_{HZ} , t_{RPST} and t_{LZ} , t_{RPRE} parameters are referenced to a specific voltage level, which specify when the device output is no longer driving (t_{HZ} , t_{RPST}), or begins driving (t_{LZ} , t_{RPRE}). t_{HZ} and t_{LZ} transitions occur in the same access time windows as valid data transitions. These parameters are verified by design and characterization, but not subject to production test.
- 14) The Auto-Refresh command interval has been reduced to 3.9 μ s when operating the DDR2 DRAM in a temperature range between 85 °C and 95 °C.
- 15) $0\text{ }^{\circ}\text{C} \leq T_{CASE} \leq 85\text{ }^{\circ}\text{C}$
- 16) $85\text{ }^{\circ}\text{C} < T_{CASE} \leq 95\text{ }^{\circ}\text{C}$
- 17) A maximum of eight Auto-Refresh commands can be posted to any given DDR2 SDRAM device.
- 18) The t_{RRD} timing parameter depends on the page size of the DRAM organization. See **Table 4 “Ordering Information for RoHS Compliant Products” on Page 5**.
- 19) The maximum limit for the t_{WPST} parameter is not a device limit. The device operates with a greater value for this parameter, but system performance (bus turnaround) degrades accordingly.
- 20) WR must be programmed to fulfill the minimum requirement for the t_{WR} timing parameter, where $WR_{MIN}[\text{cycles}] = t_{WR}(\text{ns})/t_{CK}(\text{ns})$ rounded up to the next integer value. $t_{DAL} = WR + (t_{RP}/t_{CK})$. For each of the terms, if not already an integer, round to the next highest integer. t_{CK} refers to the application clock period. WR refers to the WR parameter stored in the MRS.
- 21) Minimum t_{WTR} is two clocks when operating the DDR2-SDRAM at frequencies ≤ 200 MHz.
- 22) User can choose two different active power-down modes for additional power saving via MRS address bit A12. In “standard active power-down mode” (MR, A12 = “0”) a fast power-down exit timing t_{XARD} can be used. In “low active power-down mode” (MR, A12 = “1”) a slow power-down exit timing t_{XARDS} has to be satisfied.

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

TABLE 19
Timing Parameter by Speed Grade - DDR2-400

Parameter	Symbol	DDR2-400		Unit	Notes ¹⁾²⁾³⁾⁴⁾⁵⁾⁶⁾⁷⁾
		Min.	Max.		
DQ output access time from CK / $\overline{\text{CK}}$	t_{AC}	-600	+600	ps	
CAS A to $\overline{\text{CAS}}$ B command period	t_{CCD}	2	—	t_{CK}	
CK, $\overline{\text{CK}}$ high-level width	t_{CH}	0.45	0.55	t_{CK}	
CKE minimum high and low pulse width	t_{CKE}	3	—	t_{CK}	
CK, $\overline{\text{CK}}$ low-level width	t_{CL}	0.45	0.55	t_{CK}	
Auto-Precharge write recovery + precharge time	t_{DAL}	WR + t_{RP}	—	t_{CK}	8)22)
Minimum time clocks remain ON after CKE asynchronously drops LOW	t_{DELAY}	$t_{IS} + t_{CK} + t_{IH}$	—	ns	9)
DQ and DM input hold time (differential data strobe)	$t_{DH}(\text{base})$	275	—	ps	10)
DQ and DM input hold time (single ended data strobe)	$t_{DH1}(\text{base})$	-25	—	ps	11)
DQ and DM input pulse width (each input)	t_{DIPW}	0.35	—	t_{CK}	
DQS output access time from CK / $\overline{\text{CK}}$	t_{DQSCK}	-500	+500	ps	
DQS input low (high) pulse width (write cycle)	$t_{DQSL,H}$	0.35	—	t_{CK}	
DQS-DQ skew (for DQS & associated DQ signals)	t_{DQSQ}	—	350	ps	11)
Write command to 1st DQS latching transition	t_{DQSS}	- 0.25	+ 0.25	t_{CK}	
DQ and DM input setup time (differential data strobe)	$t_{DS}(\text{base})$	150	—	ps	11)
DQ and DM input setup time (single ended data strobe)	$t_{DS1}(\text{base})$	-25	—	ps	11)
DQS falling edge hold time from CK (write cycle)	t_{DSH}	0.2	—	t_{CK}	
DQS falling edge to CK setup time (write cycle)	t_{DSS}	0.2	—	t_{CK}	
Four Activate Window period	t_{FAW}	37.5	—	ns	13)
		50	—	ns	
Clock half period	t_{HP}	MIN. (t_{CL}, t_{CH})			12)
Data-out high-impedance time from CK / $\overline{\text{CK}}$	t_{HZ}	—	$t_{AC,MAX}$	ps	13)
Address and control input hold time	$t_{IH}(\text{base})$	475	—	ps	11)
Address and control input pulse width (each input)	t_{IPW}	0.6	—	t_{CK}	
Address and control input setup time	$t_{IS}(\text{base})$	350	—	ps	11)
DQ low-impedance time from CK / $\overline{\text{CK}}$	$t_{LZ(DQ)}$	$2 \times t_{AC,MIN}$	$t_{AC,MAX}$	ps	14)
DQS low-impedance from CK / $\overline{\text{CK}}$	$t_{LZ(DQS)}$	$t_{AC,MIN}$	$t_{AC,MAX}$	ps	14)
Mode register set command cycle time	t_{MRD}	2	—	t_{CK}	
OCD drive mode output delay	t_{OIT}	0	12	ns	
Data output hold time from DQS	t_{QH}	$t_{HP} - t_{QHS}$	—		

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Parameter	Symbol	DDR2-400		Unit	Notes ¹⁾²⁾³⁾⁴⁾⁵⁾⁶⁾⁷⁾
		Min.	Max.		
Data hold skew factor	t_{QHS}	—	450	ps	
Average periodic refresh Interval	t_{REFI}	—	7.8	μ s	14)15)
		—	3.9	μ s	16)18)
Auto-Refresh to Active/Auto-Refresh command period		105	—	ns	17)
Precharge-All (4 banks) command period	t_{RP}	$t_{RP} + 1t_{CK}$	—	ns	
Precharge-All (8 banks) command period	t_{RP}	$15 + 1t_{CK}$	—	ns	
Read preamble	t_{RPRE}	0.9	1.1	t_{CK}	14)
Read postamble	t_{RPST}	0.40	0.60	t_{CK}	14)
Active bank A to Active bank B command period	t_{RRD}	7.5	—	ns	14)18)
		10	—	ns	16)20)
Internal Read to Precharge command delay	t_{RTP}	7.5	—	ns	
Write preamble	t_{WPRE}	$0.25 \times t_{CK}$	—	t_{CK}	
Write postamble	t_{WPST}	0.40	0.60	t_{CK}	19)
Write recovery time for write without Auto-Precharge	t_{WR}	15	—	ns	
Write recovery time for write with Auto-Precharge	WR	t_{WR}/t_{CK}		t_{CK}	20)
Internal Write to Read command delay	t_{WTR}	10	—	ns	21)
Exit power down to any valid command (other than NOP or Deselect)	t_{XARD}	2	—	t_{CK}	22)
Exit active power-down mode to Read command (slow exit, lower power)	t_{XARDS}	6 – AL	—	t_{CK}	22)
Exit precharge power-down to any valid command (other than NOP or Deselect)	t_{XP}	2	—	t_{CK}	
Exit Self-Refresh to non-Read command	t_{XSNR}	$t_{RFC} + 10$	—	ns	
Exit Self-Refresh to Read command	t_{XSRD}	200	—	t_{CK}	

- 1) For details and notes see the relevant Qimonda component data sheet
- 2) $V_{DDQ} = 1.8 \text{ V} \pm 0.1 \text{ V}$; $V_{DD} = 1.8 \text{ V} \pm 0.1 \text{ V}$. See notes ⁵⁾⁶⁾⁷⁾⁸⁾
- 3) Timing that is not specified is illegal and after such an event, in order to guarantee proper operation, the DRAM must be powered down and then restarted through the specified initialization sequence before normal operation can continue.
- 4) Timings are guaranteed with $\overline{CK}/\overline{CK}$ differential Slew Rate of 2.0 V/ns. For DQS signals timings are guaranteed with a differential Slew Rate of 2.0 V/ns in differential strobe mode and a Slew Rate of 1 V/ns in single ended mode.
- 5) The $\overline{CK} / \overline{CK}$ input reference level (for timing reference to $\overline{CK} / \overline{CK}$) is the point at which \overline{CK} and \overline{CK} cross. The $\overline{DQS} / \overline{DQS}$, $\overline{RDQS} / \overline{RDQS}$, input reference level is the crosspoint when in differential strobe mode.
- 6) Inputs are not recognized as valid until V_{REF} stabilizes. During the period before V_{REF} stabilizes, $\overline{CKE} = 0.2 \times V_{DDQ}$ is recognized as low.
- 7) The output timing reference voltage level is V_{TT} .
- 8) For each of the terms, if not already an integer, round to the next highest integer. t_{CK} refers to the application clock period. WR refers to the WR parameter stored in the MR.
- 9) The clock frequency is allowed to change during self-refresh mode or precharge power-down mode.
- 10) For timing definition, refer to the Component data sheet.
- 11) Consists of data pin skew and output pattern effects, and p-channel to n-channel variation of the output drivers as well as output Slew Rate mis-match between $\overline{DQS} / \overline{DQS}$ and associated \overline{DQ} in any given cycle.
- 12) MIN (t_{CL} , t_{CH}) refers to the smaller of the actual clock low time and the actual clock high time as provided to the device (i.e. this value can be greater than the minimum specification limits for t_{CL} and t_{CH}).

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

- 13) The t_{HZ} , t_{RPST} and t_{LZ} , t_{RPRE} parameters are referenced to a specific voltage level, which specify when the device output is no longer driving (t_{HZ} , t_{RPST}), or begins driving (t_{LZ} , t_{RPRE}). t_{HZ} and t_{LZ} transitions occur in the same access time windows as valid data transitions. These parameters are verified by design and characterization, but not subject to production test.
- 14) The Auto-Refresh command interval has been reduced to 3.9 μ s when operating the DDR2 DRAM in a temperature range between 85 °C and 95 °C.
- 15) $0\text{ }^{\circ}\text{C} \leq T_{CASE} \leq 85\text{ }^{\circ}\text{C}$
- 16) $85\text{ }^{\circ}\text{C} < T_{CASE} \leq 95\text{ }^{\circ}\text{C}$
- 17) A maximum of eight Auto-Refresh commands can be posted to any given DDR2 SDRAM device.
- 18) The t_{RRD} timing parameter depends on the page size of the DRAM organization. See **Table 4 "Ordering Information for RoHS Compliant Products" on Page 5**.
- 19) The maximum limit for the t_{WPST} parameter is not a device limit. The device operates with a greater value for this parameter, but system performance (bus turnaround) degrades accordingly.
- 20) WR must be programmed to fulfill the minimum requirement for the t_{WR} timing parameter, where $WR_{MIN}[\text{cycles}] = t_{WR}(\text{ns})/t_{CK}(\text{ns})$ rounded up to the next integer value. $t_{DAL} = WR + (t_{RP}/t_{CK})$. For each of the terms, if not already an integer, round to the next highest integer. t_{CK} refers to the application clock period. WR refers to the WR parameter stored in the MRS.
- 21) Minimum t_{WTR} is two clocks when operating the DDR2-SDRAM at frequencies ≤ 200 MHz.
- 22) User can choose two different active power-down modes for additional power saving via MRS address bit A12. In "standard active power-down mode" (MR, A12 = "0") a fast power-down exit timing t_{XARD} can be used. In "low active power-down mode" (MR, A12 = "1") a slow power-down exit timing t_{XARDS} has to be satisfied.

3.3.3 ODT AC Electrical Characteristics

This chapter contains the ODT AC electrical characteristics tables.

TABLE 20
ODT AC Characteristics and Operating Conditions for DDR2-667

Symbol	Parameter / Condition	Values		Unit	Note
		Min.	Max.		
t_{AOND}	ODT turn-on delay	2	2	t_{CK}	
t_{AON}	ODT turn-on	$t_{AC.MIN}$	$t_{AC.MAX} + 0.7 \text{ ns}$	ns	1)
t_{AONPD}	ODT turn-on (Power-Down Modes)	$t_{AC.MIN} + 2 \text{ ns}$	$2 t_{CK} + t_{AC.MAX} + 1 \text{ ns}$	ns	
t_{AOFD}	ODT turn-off delay	2.5	2.5	t_{CK}	
t_{AOF}	ODT turn-off	$t_{AC.MIN}$	$t_{AC.MAX} + 0.6 \text{ ns}$	ns	2)
t_{AOFPD}	ODT turn-off (Power-Down Modes)	$t_{AC.MIN} + 2 \text{ ns}$	$2.5 t_{CK} + t_{AC.MAX} + 1 \text{ ns}$	ns	
t_{ANPD}	ODT to Power Down Mode Entry Latency	3	—	t_{CK}	
t_{AXPD}	ODT Power Down Exit Latency	8	—	t_{CK}	

- 1) ODT turn on time min. is when the device leaves high impedance and ODT resistance begins to turn on. ODT turn on time max is when the ODT resistance is fully on. Both are measure from t_{AOND} .
- 2) ODT turn off time min. is when the device starts to turn off ODT resistance. ODT turn off time max is when the bus is in high impedance. Both are measured from t_{AOFD} .

TABLE 21
ODT AC Characteristics and Operating Conditions for DDR2-533/DDR2-400

Symbol	Parameter / Condition	Values		Unit	Note
		Min.	Max.		
t_{AOND}	ODT turn-on delay	2	2	t_{CK}	
t_{AON}	ODT turn-on	$t_{AC.MIN}$	$t_{AC.MAX} + 1 \text{ ns}$	ns	1)
t_{AONPD}	ODT turn-on (Power-Down Modes)	$t_{AC.MIN} + 2 \text{ ns}$	$2 t_{CK} + t_{AC.MAX} + 1 \text{ ns}$	ns	
t_{AOFD}	ODT turn-off delay	2.5	2.5	t_{CK}	
t_{AOF}	ODT turn-off	$t_{AC.MIN}$	$t_{AC.MAX} + 0.6 \text{ ns}$	ns	2)
t_{AOFPD}	ODT turn-off (Power-Down Modes)	$t_{AC.MIN} + 2 \text{ ns}$	$2.5 t_{CK} + t_{AC.MAX} + 1 \text{ ns}$	ns	
t_{ANPD}	ODT to Power Down Mode Entry Latency	3	—	t_{CK}	
t_{AXPD}	ODT Power Down Exit Latency	8	—	t_{CK}	

- 1) ODT turn on time min. is when the device leaves high impedance and ODT resistance begins to turn on. ODT turn on time max is when the ODT resistance is fully on. Both are measure from t_{AOND} .
- 2) ODT turn off time min. is when the device starts to turn off ODT resistance. ODT turn off time max is when the bus is in high impedance. Both are measured from t_{AOFD} .

3.4 Currents Specifications and Conditions

Chapter contains current tables for each of the product types and the definitions of the various currents.

- **Table 22** “IDD Measurement Conditions” on Page 32
- **Table 23** “Definitions for IDD” on Page 33
- **Table 24** “IDD Specification for HYS[64/72]T[32/64/128]xxxHU-3-A” on Page 34
- **Table 25** “IDD Specification for HYS[64/72]T[32/64/128]xxxHU-3S-A” on Page 35
- **Table 26** “IDD Specification for HYS[64/72]T[32/64/128]xxxHU-3.7-A” on Page 36

TABLE 22
 I_{DD} Measurement Conditions

Parameter	Symbol	Note 1)2)3)4)5)
Operating Current 0 One bank Active - Precharge; $t_{CK} = t_{CK.MIN}$, $t_{RC} = t_{RC.MIN}$, $t_{RAS} = t_{RAS.MIN}$, CKE is HIGH, \overline{CS} is HIGH between valid commands. Address and control inputs are SWITCHING, Databus inputs are SWITCHING.	I_{DD0}	
Operating Current 1 One bank Active - Read - Precharge; $I_{OUT} = 0$ mA, $BL = 4$, $t_{CK} = t_{CK.MIN}$, $t_{RC} = t_{RC.MIN}$, $t_{RAS} = t_{RAS.MIN}$, $t_{RCD} = t_{RCD.MIN}$, $AL = 0$, $CL = CL_{MIN}$; CKE is HIGH, \overline{CS} is HIGH between valid commands. Address and control inputs are SWITCHING, Databus inputs are SWITCHING.	I_{DD1}	6)
Precharge Standby Current All banks idle; \overline{CS} is HIGH; CKE is HIGH; $t_{CK} = t_{CK.MIN}$; Other control and address inputs are SWITCHING, Databus inputs are SWITCHING.	I_{DD2N}	
Precharge Power-Down Current Other control and address inputs are STABLE, Data bus inputs are FLOATING.	I_{DD2P}	
Precharge Quiet Standby Current All banks idle; \overline{CS} is HIGH; CKE is HIGH; $t_{CK} = t_{CK.MIN}$; Other control and address inputs are STABLE, Data bus inputs are FLOATING.	I_{DD2Q}	
Active Standby Current Burst Read: All banks open; Continuous burst reads; $BL = 4$; $AL = 0$, $CL = CL_{MIN}$; $t_{CK} = t_{CK.MIN}$; $t_{RAS} = t_{RAS.MAX}$, $t_{RP} = t_{RP.MIN}$; CKE is HIGH, \overline{CS} is HIGH between valid commands. Address inputs are SWITCHING; Data Bus inputs are SWITCHING; $I_{OUT} = 0$ mA.	I_{DD3N}	
Active Power-Down Current All banks open; $t_{CK} = t_{CK.MIN}$, CKE is LOW; Other control and address inputs are STABLE, Data bus inputs are FLOATING. MRS A12 bit is set to LOW (Fast Power-down Exit);	$I_{DD3P(0)}$	
Active Power-Down Current All banks open; $t_{CK} = t_{CK.MIN}$, CKE is LOW; Other control and address inputs are STABLE, Data bus inputs are FLOATING. MRS A12 bit is set to HIGH (Slow Power-down Exit);	$I_{DD3P(1)}$	
Operating Current - Burst Read All banks open; Continuous burst reads; $BL = 4$; $AL = 0$, $CL = CL_{MIN}$; $t_{CK} = t_{CK.MIN}$; $t_{RAS} = t_{RAS.MAX}$; $t_{RP} = t_{RP.MIN}$; CKE is HIGH, \overline{CS} is HIGH between valid commands; Address inputs are SWITCHING; Data bus inputs are SWITCHING; $I_{OUT} = 0$ mA.	I_{DD4R}	6)
Operating Current - Burst Write All banks open; Continuous burst writes; $BL = 4$; $AL = 0$, $CL = CL_{MIN}$; $t_{CK} = t_{CK.MIN}$; $t_{RAS} = t_{RAS.MAX}$, $t_{RP} = t_{RP.MAX}$; CKE is HIGH, \overline{CS} is HIGH between valid commands. Address inputs are SWITCHING; Data Bus inputs are SWITCHING;	I_{DD4W}	
Burst Refresh Current $t_{CK} = t_{CK.MIN}$; Refresh command every $t_{RFC} = t_{RFC.MIN}$ interval, CKE is HIGH, \overline{CS} is HIGH between valid commands, Other control and address inputs are SWITCHING, Data bus inputs are SWITCHING.	I_{DD5B}	

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
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Parameter	Symbol	Note 1)2)3)4)5)
Distributed Refresh Current $t_{CK} = t_{CK,MIN}$, Refresh command every $t_{RFC} = t_{REFI}$ interval, \overline{CKE} is LOW and \overline{CS} is HIGH between valid commands, Other control and address inputs are SWITCHING, Data bus inputs are SWITCHING.	I_{DD5D}	
Self-Refresh Current $\overline{CKE} \leq 0.2$ V; external clock off, CK and \overline{CK} at 0 V; Other control and address inputs are FLOATING, Data bus inputs are FLOATING. I_{DD6} current values are guaranteed up to T_{CASE} of 85 °C max.	I_{DD6}	
All Bank Interleave Read Current All banks are being interleaved at minimum t_{RC} without violating t_{RRD} using a burst length of 4. Control and address bus inputs are STABLE during DESELECTS. $I_{out} = 0$ mA.	I_{DD7}	6)

- 1) $V_{DDQ} = 1.8 \text{ V} \pm 0.1 \text{ V}$; $V_{DD} = 1.8 \text{ V} \pm 0.1 \text{ V}$
- 2) I_{DD} specifications are tested after the device is properly initialized and I_{DD} parameter are specified with ODT disabled.
- 3) Definitions for I_{DD} see **Table 23**
- 4) For two rank modules: All active current measurements in the same I_{DD} current mode. The other rank is in I_{DD2P} Precharge Power-Down Mode
- 5) For details and notes see the relevant Qimonda component data sheet
- 6) I_{DD1} , I_{DD4R} and I_{DD7} current measurements are defined with the outputs disabled ($I_{OUT} = 0$ mA). To achieve this on module level the output buffers can be disabled using an EMRS(1) (Extended Mode Register Command) by setting A12 bit to HIGH.

TABLE 23
Definitions for I_{DD}

Parameter	Description
LOW	$V_{IN} \leq V_{IL(ac),MAX}$, HIGH is defined as $V_{IN} \geq V_{IH(ac),MIN}$
STABLE	Inputs are stable at a HIGH or LOW level
FLOATING	Inputs are $V_{REF} = V_{DDQ}/2$
SWITCHING	Inputs are changing between HIGH and LOW every other clock (once per 2 cycles) for address and control signals, and inputs changing between HIGH and LOW every other data transfer (once per cycle) for DQ signals not including mask or strobes

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TABLE 24

I_{DD} Specification for HYS[64/72]T[32/64/128]xxxHU-3-A

Product Type	HYS64T32000HU-3-A	HYS64T64000HU-3-A	HYS72T64000HU-3-A	HYS64T128020HU-3-A	HYS72T128020HU-3-A	Unit	Note ¹⁾
Organization	256MB	512MB	512MB	1GB	1GB		
	1 Rank	1 Rank	1 Rank	2 Ranks	2 Ranks		
	×64	×64	×72	×64	×72		
	-3	-3	-3	-3	-3		
Symbol	Max.	Max.	Max.	Max.	Max.		
I_{DD0}	380	600	680	640	720	mA	²⁾
I_{DD1}	440	720	810	760	860	mA	²⁾
I_{DD2N}	200	400	450	800	900	mA	³⁾
I_{DD2P}	20	40	50	80	90	mA	³⁾
I_{DD2Q}	160	320	360	640	720	mA	³⁾
I_{DD3N}	200	400	450	800	900	mA	³⁾
$I_{DD3P}(MRS = 0)$	80	150	170	300	340	mA	³⁾
$I_{DD3P}(MRS = 1)$	20	50	50	100	110	mA	³⁾
I_{DD4R}	600	1040	1170	1080	1220	mA	²⁾
I_{DD4W}	680	1120	1260	1160	1310	mA	²⁾
I_{DD5B}	560	1120	1260	1160	1310	mA	²⁾
I_{DD5D}	20	50	50	100	110	mA	³⁾
I_{DD6}	20	40	45	80	90	mA	³⁾
I_{DD7}	960	1240	1400	1280	1440	mA	²⁾

1) Calculated values from component data. ODT disabled. I_{DD1} , I_{DD4R} , and I_{DD7} are defined with the outputs disabled.

2) The other rank is in I_{DD2P} Precharge Power-Down mode

3) Both ranks are in the same I_{DD} current mode

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
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TABLE 25

I_{DD} Specification for HYS[64/72]T[32/64/128]xxxHU-3S-A

Product Type	HYS64T32000HU-3S-A HYS64T32900HU-3S-A	HYS64T64000HU-3S-A HYS64T64900HU-3S-A	HYS72T64000HU-3S-A	HYS64T128020HU-3S-A HYS64T128920HU-3S-A	HYS72T128020HU-3S-A	Unit	Note ¹⁾
Organization	256MB	512MB	512MB	1GB	1GB		
	1 Rank	1 Rank	1 Rank	2 Ranks	2 Ranks		
	×64	×64	×72	×64	×72		
	-3S	-3S	-3S	-3S	-3S		
Symbol	Max.	Max.	Max.	Max.	Max.		
I_{DD0}	360	570	640	610	680	mA	²⁾
I_{DD1}	420	680	770	720	810	mA	²⁾
I_{DD2N}	200	400	450	800	900	mA	³⁾
I_{DD2P}	20	40	50	80	90	mA	³⁾
I_{DD2Q}	160	320	360	640	720	mA	³⁾
I_{DD3N}	200	400	450	800	900	mA	³⁾
I_{DD3P} (MRS = 0)	80	150	170	300	340	mA	³⁾
I_{DD3P} (MRS = 1)	20	50	50	100	110	mA	³⁾
I_{DD4R}	600	1040	1170	1080	1220	mA	²⁾
I_{DD4W}	680	1120	1260	1160	1310	mA	²⁾
I_{DD5B}	560	1120	1260	1160	1310	mA	²⁾
I_{DD5D}	20	50	50	100	110	mA	³⁾
I_{DD6}	20	40	45	80	90	mA	³⁾
I_{DD7}	910	1180	1320	1220	1370	mA	²⁾

- 1) Calculated values from component data. ODT disabled. I_{DD1} , I_{DD4R} , and I_{DD7} are defined with the outputs disabled.
- 2) The other rank is in I_{DD2P} Precharge Power-Down mode
- 3) Both ranks are in the same I_{DD} current mode

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
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TABLE 26

I_{DD} Specification for HYS[64/72]T[32/64/128]xxxHU-3.7-A

Product Type	HYS64T32000HU-3.7-A HYS64T32900HU-3.7-A	HYS64T64000HU-3.7-A HYS64T64900HU-3.7-A	HYS72T64000HU-3.7-A	HYS64T128020HU-3.7-A HYS64T128920HU-3.7-A	HYS72T128020HU-3.7-A	Unit	Note ¹⁾
Organization	256MB	512MB	512MB	1GB	1GB		
	1 Rank	1 Rank	1 Rank	2 Ranks	2 Ranks		
	×64	×64	×72	×64	×72		
	-3.7	-3.7	-3.7	-3.7	-3.7		
Symbol	Max.	Max.	Max.	Max.	Max.		
I_{DD0}	320	520	590	550	620	mA	²⁾
I_{DD1}	360	600	680	630	710	mA	²⁾
I_{DD2N}	160	320	360	640	720	mA	³⁾
I_{DD2P}	20	30	40	60	70	mA	³⁾
I_{DD2Q}	120	240	270	480	540	mA	³⁾
I_{DD3N}	160	320	360	640	720	mA	³⁾
I_{DD3P} (MRS = 0)	60	130	140	260	290	mA	³⁾
I_{DD3P} (MRS = 1)	20	40	50	80	90	mA	³⁾
I_{DD4R}	400	720	810	750	850	mA	²⁾
I_{DD4W}	440	760	860	790	890	mA	²⁾
I_{DD5B}	520	1040	1170	1070	1210	mA	²⁾
I_{DD5D}	20	50	50	100	110	mA	³⁾
I_{DD6}	16	32	36	64	72	mA	³⁾
I_{DD7}	880	1120	1260	1160	1300	mA	²⁾

1) Calculated values from component data. ODT disabled. I_{DD1} , I_{DD4R} , and I_{DD7} are defined with the outputs disabled.

2) The other rank is in I_{DD2P} Precharge Power-Down mode

3) Both ranks are in the same I_{DD} current mode

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

TABLE 27

I_{DD} Specification for HYS[64/72]T[32/64/128]xxxHU-5-A

Product Type	HYS64T32000HU-5-A	HYS64T64000HU-5-A	HYS72T64000HU-5-A	HYS64T128020HU-5-A	HYS72T128020HU-5-A	Unit	Note ¹⁾
Organization	256MB	512MB	512MB	1GB	1GB		
	1 Rank	1 Rank	1 Rank	2 Ranks	2 Ranks		
	×64	×64	×72	×64	×72		
	-5	-5	-5	-5	-5		
Symbol	Max.	Max.	Max.	Max.	Max.		
I_{DD0}	280	440	500	470	530	mA	²⁾
I_{DD1}	300	480	540	510	580	mA	²⁾
I_{DD2N}	130	260	290	510	580	mA	³⁾
I_{DD2P}	20	30	40	60	70	mA	³⁾
I_{DD2Q}	100	200	230	400	450	mA	³⁾
I_{DD3N}	140	280	320	560	630	mA	³⁾
$I_{DD3P}(MRS = 0)$	50	100	120	210	230	mA	³⁾
$I_{DD3P}(MRS = 1)$	20	40	50	80	90	mA	³⁾
I_{DD4R}	340	560	630	590	670	mA	²⁾
I_{DD4W}	360	600	680	630	710	mA	²⁾
I_{DD5B}	480	960	1080	990	1120	mA	²⁾
I_{DD5D}	20	50	50	100	110	mA	³⁾
I_{DD6}	16	32	36	64	72	mA	³⁾
I_{DD7}	840	1040	1170	1070	1210	mA	²⁾

- 1) Calculated values from component data. ODT disabled. I_{DD1} , I_{DD4R} , and I_{DD7} are defined with the outputs disabled.
- 2) The other rank is in I_{DD2P} Precharge Power-Down mode
- 3) Both ranks are in the same I_{DD} current mode

4 SPD Codes

This chapter lists all hexadecimal byte values stored in the EEPROM of the products described in this data sheet. SPD stands for serial presence detect. All values with XX in the table are module specific bytes which are defined during production.

List of SPD Code Tables

- Table 28 “HYS[64/72]T[32/64/128]0x0HU-3-A” on Page 38
- Table 29 “HYS[64/72]T[32/64]x00HU-3S-A” on Page 43
- Table 30 “HYS[64/72]T128x20HU-3S-A” on Page 48
- Table 31 “HYS[64/72]T[32/64]x00HU-3.7-A” on Page 52
- Table 32 “HYS[64/72]T128x20HU-3.7-A” on Page 57
- Table 33 “HYS[64/72]T[32/64/128]0x0HU-5-A” on Page 61

TABLE 28
HYS[64/72]T[32/64/128]0x0HU-3-A

Product Type		HYS64T32000HU-3-A	HYS64T64000HU-3-A	HYS72T64000HU-3-A	HYS64T128020HU-3-A	HYS72T128020HU-3-A
Organization		256MB ×64 1 Rank (×16)	512MB ×64 1 Rank (×8)	512MB ×72 1 Rank (×8)	1 GByte ×64 2 Ranks (×8)	1 GByte ×72 2 Ranks (×8)
Label Code		PC2- 5300U- 444	PC2- 5300U- 444	PC2- 5300E- 444	PC2- 5300U- 444	PC2- 5300E- 444
JEDEC SPD Revision		Rev. 1.2	Rev. 1.2	Rev. 1.2	Rev. 1.2	Rev. 1.2
Byte#	Description	HEX	HEX	HEX	HEX	HEX
0	Programmed SPD Bytes in EEPROM	80	80	80	80	80
1	Total number of Bytes in EEPROM	08	08	08	08	08
2	Memory Type (DDR2)	08	08	08	08	08
3	Number of Row Addresses	0D	0E	0E	0E	0E
4	Number of Column Addresses	0A	0A	0A	0A	0A
5	DIMM Rank and Stacking Information	60	60	60	61	61
6	Data Width	40	40	48	40	48
7	Not used	00	00	00	00	00
8	Interface Voltage Level	05	05	05	05	05

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
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Product Type		HYS64T32000HU-3-A	HYS64T64000HU-3-A	HYS72T64000HU-3-A	HYS64T128020HU-3-A	HYS72T128020HU-3-A
Organization		256MB	512MB	512MB	1 GByte	1 GByte
		×64	×64	×72	×64	×72
		1 Rank (×16)	1 Rank (×8)	1 Rank (×8)	2 Ranks (×8)	2 Ranks (×8)
Label Code		PC2-5300U-444	PC2-5300U-444	PC2-5300E-444	PC2-5300U-444	PC2-5300E-444
JEDEC SPD Revision		Rev. 1.2	Rev. 1.2	Rev. 1.2	Rev. 1.2	Rev. 1.2
Byte#	Description	HEX	HEX	HEX	HEX	HEX
9	$t_{CK} @ CL_{MAX}$ (Byte 18) [ns]	30	30	30	30	30
10	t_{AC} SDRAM @ CL_{MAX} (Byte 18) [ns]	45	45	45	45	45
11	Error Correction Support (non-ECC, ECC)	00	00	02	00	02
12	Refresh Rate and Type	82	82	82	82	82
13	Primary SDRAM Width	10	08	08	08	08
14	Error Checking SDRAM Width	00	00	08	00	08
15	Not used	00	00	00	00	00
16	Burst Length Supported	0C	0C	0C	0C	0C
17	Number of Banks on SDRAM Device	04	04	04	04	04
18	Supported CAS Latencies	38	38	38	38	38
19	DIMM Mechanical Characteristics	01	01	01	01	01
20	DIMM Type Information	02	02	02	02	02
21	DIMM Attributes	00	00	00	00	00
22	Component Attributes	03	03	03	03	03
23	$t_{CK} @ CL_{MAX} -1$ (Byte 18) [ns]	30	30	30	30	30
24	t_{AC} SDRAM @ $CL_{MAX} -1$ [ns]	45	45	45	45	45
25	$t_{CK} @ CL_{MAX} -2$ (Byte 18) [ns]	50	50	50	50	50
26	t_{AC} SDRAM @ $CL_{MAX} -2$ [ns]	60	60	60	60	60
27	$t_{RP.MIN}$ [ns]	30	30	30	30	30
28	$t_{RRD.MIN}$ [ns]	28	1E	1E	1E	1E
29	$t_{RCD.MIN}$ [ns]	30	30	30	30	30
30	$t_{RAS.MIN}$ [ns]	2D	2D	2D	2D	2D
31	Module Density per Rank	40	80	80	80	80
32	$t_{AS.MIN}$ and $t_{CS.MIN}$ [ns]	20	20	20	20	20

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
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Product Type		HYS64T32000HU-3-A	HYS64T64000HU-3-A	HYS72T64000HU-3-A	HYS64T128020HU-3-A	HYS72T128020HU-3-A
Organization		256MB	512MB	512MB	1 GByte	1 GByte
		×64	×64	×72	×64	×72
		1 Rank (×16)	1 Rank (×8)	1 Rank (×8)	2 Ranks (×8)	2 Ranks (×8)
Label Code		PC2- 5300U- 444	PC2- 5300U- 444	PC2- 5300E- 444	PC2- 5300U- 444	PC2- 5300E- 444
JEDEC SPD Revision		Rev. 1.2	Rev. 1.2	Rev. 1.2	Rev. 1.2	Rev. 1.2
Byte#	Description	HEX	HEX	HEX	HEX	HEX
33	$t_{AH.MIN}$ and $t_{CH.MIN}$ [ns]	27	27	27	27	27
34	$t_{DS.MIN}$ [ns]	10	10	10	10	10
35	$t_{DH.MIN}$ [ns]	17	17	17	17	17
36	$t_{WR.MIN}$ [ns]	3C	3C	3C	3C	3C
37	$t_{WTR.MIN}$ [ns]	1E	1E	1E	1E	1E
38	$t_{RTP.MIN}$ [ns]	1E	1E	1E	1E	1E
39	Analysis Characteristics	00	00	00	00	00
40	t_{RC} and t_{RFC} Extension	00	00	00	00	00
41	$t_{RC.MIN}$ [ns]	39	39	39	39	39
42	$t_{RFC.MIN}$ [ns]	69	69	69	69	69
43	$t_{CK.MAX}$ [ns]	80	80	80	80	80
44	$t_{DQSQ.MAX}$ [ns]	18	18	18	18	18
45	$t_{QHS.MAX}$ [ns]	22	22	22	22	22
46	PLL Relock Time	00	00	00	00	00
47	$T_{CASE.MAX}$ Delta / ΔT_{4R4W} Delta	55	53	53	53	53
48	Psi(T-A) DRAM	72	78	78	78	78
49	ΔT_0 (DT0)	67	4F	4F	4F	4F
50	ΔT_{2N} (DT2N, UDIMM) or ΔT_{2Q} (DT2Q, RDIMM)	36	39	39	39	39
51	ΔT_{2P} (DT2P)	24	26	26	26	26
52	ΔT_{3N} (DT3N)	24	26	26	26	26
53	$\Delta T_{3P.fast}$ (DT3P fast)	29	2B	2B	2B	2B
54	$\Delta T_{3P.slow}$ (DT3P slow)	1A	1B	1B	1B	1B
55	ΔT_{4R} (DT4R) / ΔT_{4R4W} Sign (DT4R4W)	52	4A	4A	4A	4A
56	ΔT_{5B} (DT5B)	1E	20	20	20	20

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Product Type		HYS64T32000HU-3-A	HYS64T64000HU-3-A	HYS72T64000HU-3-A	HYS64T128020HU-3-A	HYS72T128020HU-3-A
Organization		256MB	512MB	512MB	1 GByte	1 GByte
		×64	×64	×72	×64	×72
		1 Rank (×16)	1 Rank (×8)	1 Rank (×8)	2 Ranks (×8)	2 Ranks (×8)
Label Code		PC2-5300U-444	PC2-5300U-444	PC2-5300E-444	PC2-5300U-444	PC2-5300E-444
JEDEC SPD Revision		Rev. 1.2	Rev. 1.2	Rev. 1.2	Rev. 1.2	Rev. 1.2
Byte#	Description	HEX	HEX	HEX	HEX	HEX
57	ΔT_7 (DT7)	34	23	23	23	23
58	Psi(ca) PLL	00	00	00	00	00
59	Psi(ca) REG	00	00	00	00	00
60	ΔT_{PLL} (DTPLL)	00	00	00	00	00
61	ΔT_{REG} (DTREG) / Toggle Rate	00	00	00	00	00
62	SPD Revision	12	12	12	12	12
63	Checksum of Bytes 0-62	A2	B0	C2	B1	C3
64	Manufacturer's JEDEC ID Code (1)	7F	7F	7F	7F	7F
65	Manufacturer's JEDEC ID Code (2)	7F	7F	7F	7F	7F
66	Manufacturer's JEDEC ID Code (3)	7F	7F	7F	7F	7F
67	Manufacturer's JEDEC ID Code (4)	7F	7F	7F	7F	7F
68	Manufacturer's JEDEC ID Code (5)	7F	7F	7F	7F	7F
69	Manufacturer's JEDEC ID Code (6)	51	51	51	51	51
70	Manufacturer's JEDEC ID Code (7)	00	00	00	00	00
71	Manufacturer's JEDEC ID Code (8)	00	00	00	00	00
72	Module Manufacturer Location	xx	xx	xx	xx	xx
73	Product Type, Char 1	36	36	37	36	37
74	Product Type, Char 2	34	34	32	34	32
75	Product Type, Char 3	54	54	54	54	54
76	Product Type, Char 4	33	36	36	31	31
77	Product Type, Char 5	32	34	34	32	32
78	Product Type, Char 6	30	30	30	38	38
79	Product Type, Char 7	30	30	30	30	30
80	Product Type, Char 8	30	30	30	32	32

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Product Type		HYS64T32000HU-3-A	HYS64T64000HU-3-A	HYS72T64000HU-3-A	HYS64T128020HU-3-A	HYS72T128020HU-3-A
Organization		256MB	512MB	512MB	1 GByte	1 GByte
		×64	×64	×72	×64	×72
		1 Rank (×16)	1 Rank (×8)	1 Rank (×8)	2 Ranks (×8)	2 Ranks (×8)
Label Code		PC2-5300U-444	PC2-5300U-444	PC2-5300E-444	PC2-5300U-444	PC2-5300E-444
JEDEC SPD Revision		Rev. 1.2	Rev. 1.2	Rev. 1.2	Rev. 1.2	Rev. 1.2
Byte#	Description	HEX	HEX	HEX	HEX	HEX
81	Product Type, Char 9	48	48	48	30	30
82	Product Type, Char 10	55	55	55	48	48
83	Product Type, Char 11	33	33	33	55	55
84	Product Type, Char 12	41	41	41	33	33
85	Product Type, Char 13	20	20	20	41	41
86	Product Type, Char 14	20	20	20	20	20
87	Product Type, Char 15	20	20	20	20	20
88	Product Type, Char 16	20	20	20	20	20
89	Product Type, Char 17	20	20	20	20	20
90	Product Type, Char 18	20	20	20	20	20
91	Module Revision Code	7x	9x	9x	9x	9x
92	Test Program Revision Code	xx	xx	xx	xx	xx
93	Module Manufacturing Date Year	xx	xx	xx	xx	xx
94	Module Manufacturing Date Week	xx	xx	xx	xx	xx
95 - 98	Module Serial Number	xx	xx	xx	xx	xx
99 - 127	Not used	00	00	00	00	00
128 - 255	Blank for customer use	FF	FF	FF	FF	FF

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

TABLE 29
HYS[64/72]T[32/64]x00HU-3S-A

Product Type		HYS64T32000HU-3S-A	HYS64T32900HU-3S-A	HYS64T64000HU-3S-A	HYS64T64900HU-3S-A	HYS72T64000HU-3S-A
Organization		256MB	256MB	512MB	512MB	512MB
		×64	×64	×64	×64	×72
		1 Rank (×16)	1 Rank (×16)	1 Rank (×8)	1 Rank (×8)	1 Rank (×8)
Label Code		PC2-5300U-555	PC2-5300U-555	PC2-5300U-555	PC2-5300U-555	PC2-5300E-555
JEDEC SPD Revision		Rev. 1.2	Rev. 1.2	Rev. 1.2	Rev. 1.2	Rev. 1.2
Byte#	Description	HEX	HEX	HEX	HEX	HEX
0	Programmed SPD Bytes in EEPROM	80	80	80	80	80
1	Total number of Bytes in EEPROM	08	08	08	08	08
2	Memory Type (DDR2)	08	08	08	08	08
3	Number of Row Addresses	0D	0D	0E	0E	0E
4	Number of Column Addresses	0A	0A	0A	0A	0A
5	DIMM Rank and Stacking Information	60	60	60	60	60
6	Data Width	40	40	40	40	48
7	Not used	00	00	00	00	00
8	Interface Voltage Level	05	05	05	05	05
9	$t_{CK} @ CL_{MAX}$ (Byte 18) [ns]	30	30	30	30	30
10	t_{AC} SDRAM @ CL_{MAX} (Byte 18) [ns]	45	45	45	45	45
11	Error Correction Support (non-ECC, ECC)	00	00	00	00	02
12	Refresh Rate and Type	82	82	82	82	82
13	Primary SDRAM Width	10	10	08	08	08
14	Error Checking SDRAM Width	00	00	00	00	08
15	Not used	00	00	00	00	00
16	Burst Length Supported	0C	0C	0C	0C	0C
17	Number of Banks on SDRAM Device	04	04	04	04	04
18	Supported CAS Latencies	38	38	38	38	38
19	DIMM Mechanical Characteristics	01	01	01	01	01
20	DIMM Type Information	02	02	02	02	02
21	DIMM Attributes	00	00	00	00	00

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Product Type		HYS64T32000HU-3S-A	HYS64T32900HU-3S-A	HYS64T64000HU-3S-A	HYS64T64900HU-3S-A	HYS72T64000HU-3S-A
Organization		256MB	256MB	512MB	512MB	512MB
		×64	×64	×64	×64	×72
		1 Rank (×16)	1 Rank (×16)	1 Rank (×8)	1 Rank (×8)	1 Rank (×8)
Label Code		PC2-5300U-555	PC2-5300U-555	PC2-5300U-555	PC2-5300U-555	PC2-5300E-555
JEDEC SPD Revision		Rev. 1.2	Rev. 1.2	Rev. 1.2	Rev. 1.2	Rev. 1.2
Byte#	Description	HEX	HEX	HEX	HEX	HEX
22	Component Attributes	03	03	03	03	03
23	$t_{CK} @ CL_{MAX} -1$ (Byte 18) [ns]	3D	3D	3D	3D	3D
24	t_{AC} SDRAM @ $CL_{MAX} -1$ [ns]	50	50	50	50	50
25	$t_{CK} @ CL_{MAX} -2$ (Byte 18) [ns]	50	50	50	50	50
26	t_{AC} SDRAM @ $CL_{MAX} -2$ [ns]	60	60	60	60	60
27	$t_{RP.MIN}$ [ns]	3C	3C	3C	3C	3C
28	$t_{RRD.MIN}$ [ns]	28	28	1E	1E	1E
29	$t_{RCD.MIN}$ [ns]	3C	3C	3C	3C	3C
30	$t_{RAS.MIN}$ [ns]	2D	2D	2D	2D	2D
31	Module Density per Rank	40	40	80	80	80
32	$t_{AS.MIN}$ and $t_{CS.MIN}$ [ns]	20	20	20	20	20
33	$t_{AH.MIN}$ and $t_{CH.MIN}$ [ns]	27	27	27	27	27
34	$t_{DS.MIN}$ [ns]	10	10	10	10	10
35	$t_{DH.MIN}$ [ns]	17	17	17	17	17
36	$t_{WR.MIN}$ [ns]	3C	3C	3C	3C	3C
37	$t_{WTR.MIN}$ [ns]	1E	1E	1E	1E	1E
38	$t_{RTP.MIN}$ [ns]	1E	1E	1E	1E	1E
39	Analysis Characteristics	00	00	00	00	00
40	t_{RC} and t_{RFC} Extension	00	00	00	00	00
41	$t_{RC.MIN}$ [ns]	3C	3C	3C	3C	3C
42	$t_{RFC.MIN}$ [ns]	69	69	69	69	69
43	$t_{CK.MAX}$ [ns]	80	80	80	80	80
44	$t_{DQSQ.MAX}$ [ns]	18	18	18	18	18
45	$t_{QHS.MAX}$ [ns]	22	22	22	22	22

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Product Type		HYS64T32000HU-3S-A	HYS64T32900HU-3S-A	HYS64T64000HU-3S-A	HYS64T64900HU-3S-A	HYS72T64000HU-3S-A
Organization		256MB	256MB	512MB	512MB	512MB
		×64	×64	×64	×64	×72
		1 Rank (×16)	1 Rank (×16)	1 Rank (×8)	1 Rank (×8)	1 Rank (×8)
Label Code		PC2-5300U-555	PC2-5300U-555	PC2-5300U-555	PC2-5300U-555	PC2-5300E-555
JEDEC SPD Revision		Rev. 1.2	Rev. 1.2	Rev. 1.2	Rev. 1.2	Rev. 1.2
Byte#	Description	HEX	HEX	HEX	HEX	HEX
46	PLL Relock Time	00	00	00	00	00
47	$T_{CASE,MAX}$ Delta / ΔT_{4R4W} Delta	55	55	53	53	53
48	Psi(T-A) DRAM	72	72	78	78	78
49	ΔT_0 (DT0)	5F	5F	4B	4B	4B
50	ΔT_{2N} (DT2N, UDIMM) or ΔT_{2Q} (DT2Q, RDIMM)	36	36	39	39	39
51	ΔT_{2P} (DT2P)	24	24	26	26	26
52	ΔT_{3N} (DT3N)	24	24	26	26	26
53	$\Delta T_{3P,fast}$ (DT3P fast)	29	29	2B	2B	2B
54	$\Delta T_{3P,slow}$ (DT3P slow)	1A	1A	1B	1B	1B
55	ΔT_{4R} (DT4R) / ΔT_{4R4W} Sign (DT4R4W)	52	52	4A	4A	4A
56	ΔT_{5B} (DT5B)	1E	1E	20	20	20
57	ΔT_7 (DT7)	31	31	22	22	22
58	Psi(ca) PLL	00	00	00	00	00
59	Psi(ca) REG	00	00	00	00	00
60	ΔT_{PLL} (DTPLL)	00	00	00	00	00
61	ΔT_{REG} (DTREG) / Toggle Rate	00	00	00	00	00
62	SPD Revision	12	12	12	12	12
63	Checksum of Bytes 0-62	CA	CA	DE	DE	F0
64	Manufacturer's JEDEC ID Code (1)	7F	7F	7F	7F	7F
65	Manufacturer's JEDEC ID Code (2)	7F	7F	7F	7F	7F
66	Manufacturer's JEDEC ID Code (3)	7F	7F	7F	7F	7F
67	Manufacturer's JEDEC ID Code (4)	7F	7F	7F	7F	7F
68	Manufacturer's JEDEC ID Code (5)	7F	7F	7F	7F	7F
69	Manufacturer's JEDEC ID Code (6)	51	51	51	51	51

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Product Type		HYS64T32000HU-3S-A	HYS64T32900HU-3S-A	HYS64T64000HU-3S-A	HYS64T64900HU-3S-A	HYS72T64000HU-3S-A
Organization		256MB	256MB	512MB	512MB	512MB
		×64	×64	×64	×64	×72
		1 Rank (×16)	1 Rank (×16)	1 Rank (×8)	1 Rank (×8)	1 Rank (×8)
Label Code		PC2-5300U-555	PC2-5300U-555	PC2-5300U-555	PC2-5300U-555	PC2-5300E-555
JEDEC SPD Revision		Rev. 1.2	Rev. 1.2	Rev. 1.2	Rev. 1.2	Rev. 1.2
Byte#	Description	HEX	HEX	HEX	HEX	HEX
70	Manufacturer's JEDEC ID Code (7)	00	00	00	00	00
71	Manufacturer's JEDEC ID Code (8)	00	00	00	00	00
72	Module Manufacturer Location	xx	xx	xx	xx	xx
73	Product Type, Char 1	36	36	36	36	37
74	Product Type, Char 2	34	34	34	34	32
75	Product Type, Char 3	54	54	54	54	54
76	Product Type, Char 4	33	33	36	36	36
77	Product Type, Char 5	32	32	34	34	34
78	Product Type, Char 6	30	39	30	39	30
79	Product Type, Char 7	30	30	30	30	30
80	Product Type, Char 8	30	30	30	30	30
81	Product Type, Char 9	48	48	48	48	48
82	Product Type, Char 10	55	55	55	55	55
83	Product Type, Char 11	33	33	33	33	33
84	Product Type, Char 12	53	53	53	53	53
85	Product Type, Char 13	41	41	41	41	41
86	Product Type, Char 14	20	20	20	20	20
87	Product Type, Char 15	20	20	20	20	20
88	Product Type, Char 16	20	20	20	20	20
89	Product Type, Char 17	20	20	20	20	20
90	Product Type, Char 18	20	20	20	20	20
91	Module Revision Code	4x	2x	4x	2x	4x
92	Test Program Revision Code	xx	xx	xx	xx	xx
93	Module Manufacturing Date Year	xx	xx	xx	xx	xx



HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Product Type		HYS64T32000HU-3S-A	HYS64T32900HU-3S-A	HYS64T64000HU-3S-A	HYS64T64900HU-3S-A	HYS72T64000HU-3S-A
Organization		256MB	256MB	512MB	512MB	512MB
		×64	×64	×64	×64	×72
		1 Rank (×16)	1 Rank (×16)	1 Rank (×8)	1 Rank (×8)	1 Rank (×8)
Label Code		PC2- 5300U- 555	PC2- 5300U- 555	PC2- 5300U- 555	PC2- 5300U- 555	PC2- 5300E- 555
JEDEC SPD Revision		Rev. 1.2	Rev. 1.2	Rev. 1.2	Rev. 1.2	Rev. 1.2
Byte#	Description	HEX	HEX	HEX	HEX	HEX
94	Module Manufacturing Date Week	xx	xx	xx	xx	xx
95 - 98	Module Serial Number	xx	xx	xx	xx	xx
99 - 127	Not used	00	00	00	00	00
128 - 255	Blank for customer use	FF	FF	FF	FF	FF

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

TABLE 30
HYS[64/72]T128x20HU-3S-A

Product Type		HYS64T128020HU-3S-A	HYS64T128920HU-3S-A	HYS72T128020HU-3S-A
Organization		1 GByte	1 GByte	1 GByte
		×64	×64	×72
		2 Ranks (×8)	2 Ranks (×8)	2 Ranks (×8)
Label Code		PC2-5300U-555	PC2-5300U-555	PC2-5300E-555
JEDEC SPD Revision		Rev. 1.2	Rev. 1.2	Rev. 1.2
Byte#	Description	HEX	HEX	HEX
0	Programmed SPD Bytes in EEPROM	80	80	80
1	Total number of Bytes in EEPROM	08	08	08
2	Memory Type (DDR2)	08	08	08
3	Number of Row Addresses	0E	0E	0E
4	Number of Column Addresses	0A	0A	0A
5	DIMM Rank and Stacking Information	61	61	61
6	Data Width	40	40	48
7	Not used	00	00	00
8	Interface Voltage Level	05	05	05
9	$t_{CK} @ CL_{MAX}$ (Byte 18) [ns]	30	30	30
10	t_{AC} SDRAM @ CL_{MAX} (Byte 18) [ns]	45	45	45
11	Error Correction Support (non-ECC, ECC)	00	00	02
12	Refresh Rate and Type	82	82	82
13	Primary SDRAM Width	08	08	08
14	Error Checking SDRAM Width	00	00	08
15	Not used	00	00	00
16	Burst Length Supported	0C	0C	0C
17	Number of Banks on SDRAM Device	04	04	04
18	Supported CAS Latencies	38	38	38
19	DIMM Mechanical Characteristics	01	01	01
20	DIMM Type Information	02	02	02
21	DIMM Attributes	00	00	00
22	Component Attributes	03	03	03
23	$t_{CK} @ CL_{MAX} -1$ (Byte 18) [ns]	3D	3D	3D

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Product Type		HYS64T128020HU-3S-A	HYS64T128920HU-3S-A	HYS72T128020HU-3S-A
Organization		1 GByte	1 GByte	1 GByte
		×64	×64	×72
		2 Ranks (×8)	2 Ranks (×8)	2 Ranks (×8)
Label Code		PC2-5300U-555	PC2-5300U-555	PC2-5300E-555
JEDEC SPD Revision		Rev. 1.2	Rev. 1.2	Rev. 1.2
Byte#	Description	HEX	HEX	HEX
24	t_{AC} SDRAM @ $CL_{MAX} -1$ [ns]	50	50	50
25	t_{CK} @ $CL_{MAX} -2$ (Byte 18) [ns]	50	50	50
26	t_{AC} SDRAM @ $CL_{MAX} -2$ [ns]	60	60	60
27	$t_{RP.MIN}$ [ns]	3C	3C	3C
28	$t_{RRD.MIN}$ [ns]	1E	1E	1E
29	$t_{RCD.MIN}$ [ns]	3C	3C	3C
30	$t_{RAS.MIN}$ [ns]	2D	2D	2D
31	Module Density per Rank	80	80	80
32	$t_{AS.MIN}$ and $t_{CS.MIN}$ [ns]	20	20	20
33	$t_{AH.MIN}$ and $t_{CH.MIN}$ [ns]	27	27	27
34	$t_{DS.MIN}$ [ns]	10	10	10
35	$t_{DH.MIN}$ [ns]	17	17	17
36	$t_{WR.MIN}$ [ns]	3C	3C	3C
37	$t_{WTR.MIN}$ [ns]	1E	1E	1E
38	$t_{RTP.MIN}$ [ns]	1E	1E	1E
39	Analysis Characteristics	00	00	00
40	t_{RC} and t_{RFC} Extension	00	00	00
41	$t_{RC.MIN}$ [ns]	3C	3C	3C
42	$t_{RFC.MIN}$ [ns]	69	69	69
43	$t_{CK.MAX}$ [ns]	80	80	80
44	$t_{DQSQ.MAX}$ [ns]	18	18	18
45	$t_{QHS.MAX}$ [ns]	22	22	22
46	PLL Relock Time	00	00	00
47	$T_{CASE.MAX}$ Delta / ΔT_{4R4W} Delta	53	53	53
48	Psi(T-A) DRAM	78	78	78
49	ΔT_0 (DT0)	4B	4B	4B

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Product Type		HYS64T128020HU-3S-A	HYS64T128920HU-3S-A	HYS72T128020HU-3S-A
Organization		1 GByte	1 GByte	1 GByte
		×64	×64	×72
		2 Ranks (×8)	2 Ranks (×8)	2 Ranks (×8)
Label Code		PC2-5300U-555	PC2-5300U-555	PC2-5300E-555
JEDEC SPD Revision		Rev. 1.2	Rev. 1.2	Rev. 1.2
Byte#	Description	HEX	HEX	HEX
50	ΔT_{2N} (DT2N, UDIMM) or ΔT_{2Q} (DT2Q, RDIMM)	39	39	39
51	ΔT_{2P} (DT2P)	26	26	26
52	ΔT_{3N} (DT3N)	26	26	26
53	$\Delta T_{3P.fast}$ (DT3P fast)	2B	2B	2B
54	$\Delta T_{3P.slow}$ (DT3P slow)	1B	1B	1B
55	ΔT_{4R} (DT4R) / ΔT_{4R4W} Sign (DT4R4W)	4A	4A	4A
56	ΔT_{5B} (DT5B)	20	20	20
57	ΔT_7 (DT7)	22	22	22
58	Psi(ca) PLL	00	00	00
59	Psi(ca) REG	00	00	00
60	ΔT_{PLL} (DTPLL)	00	00	00
61	ΔT_{REG} (DTREG) / Toggle Rate	00	00	00
62	SPD Revision	12	12	12
63	Checksum of Bytes 0-62	DF	DF	F1
64	Manufacturer's JEDEC ID Code (1)	7F	7F	7F
65	Manufacturer's JEDEC ID Code (2)	7F	7F	7F
66	Manufacturer's JEDEC ID Code (3)	7F	7F	7F
67	Manufacturer's JEDEC ID Code (4)	7F	7F	7F
68	Manufacturer's JEDEC ID Code (5)	7F	7F	7F
69	Manufacturer's JEDEC ID Code (6)	51	51	51
70	Manufacturer's JEDEC ID Code (7)	00	00	00
71	Manufacturer's JEDEC ID Code (8)	00	00	00
72	Module Manufacturer Location	xx	xx	xx
73	Product Type, Char 1	36	36	37
74	Product Type, Char 2	34	34	32
75	Product Type, Char 3	54	54	54

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Product Type		HYS64T128020HU-3S-A	HYS64T128920HU-3S-A	HYS72T128020HU-3S-A
Organization		1 GByte	1 GByte	1 GByte
		×64	×64	×72
		2 Ranks (×8)	2 Ranks (×8)	2 Ranks (×8)
Label Code		PC2-5300U-555	PC2-5300U-555	PC2-5300E-555
JEDEC SPD Revision		Rev. 1.2	Rev. 1.2	Rev. 1.2
Byte#	Description	HEX	HEX	HEX
76	Product Type, Char 4	31	31	31
77	Product Type, Char 5	32	32	32
78	Product Type, Char 6	38	38	38
79	Product Type, Char 7	30	39	30
80	Product Type, Char 8	32	32	32
81	Product Type, Char 9	30	30	30
82	Product Type, Char 10	48	48	48
83	Product Type, Char 11	55	55	55
84	Product Type, Char 12	33	33	33
85	Product Type, Char 13	53	53	53
86	Product Type, Char 14	41	41	41
87	Product Type, Char 15	20	20	20
88	Product Type, Char 16	20	20	20
89	Product Type, Char 17	20	20	20
90	Product Type, Char 18	20	20	20
91	Module Revision Code	4x	2x	4x
92	Test Program Revision Code	xx	xx	xx
93	Module Manufacturing Date Year	xx	xx	xx
94	Module Manufacturing Date Week	xx	xx	xx
95 - 98	Module Serial Number	xx	xx	xx
99 - 127	Not used	00	00	00
128 - 255	Blank for customer use	FF	FF	FF

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

TABLE 31
HYS[64/72]T[32/64]x00HU-3.7-A

Product Type		HYS64T32000HU-3.7-A	HYS64T32900HU-3.7-A	HYS64T64000HU-3.7-A	HYS64T64900HU-3.7-A	HYS72T64000HU-3.7-A
Organization		256MB ×64 1 Rank (×16)	256MB ×64 1 Rank (×16)	512MB ×64 1 Rank (×8)	512MB ×64 1 Rank (×8)	512MB ×72 1 Rank (×8)
Label Code		PC2-4200U-444	PC2-4200U-444	PC2-4200U-444	PC2-4200U-444	PC2-4200E-444
JEDEC SPD Revision		Rev. 1.1	Rev. 1.2	Rev. 1.1	Rev. 1.2	Rev. 1.1
Byte#	Description	HEX	HEX	HEX	HEX	HEX
0	Programmed SPD Bytes in EEPROM	80	80	80	80	80
1	Total number of Bytes in EEPROM	08	08	08	08	08
2	Memory Type (DDR2)	08	08	08	08	08
3	Number of Row Addresses	0D	0D	0E	0E	0E
4	Number of Column Addresses	0A	0A	0A	0A	0A
5	DIMM Rank and Stacking Information	60	60	60	60	60
6	Data Width	40	40	40	40	48
7	Not used	00	00	00	00	00
8	Interface Voltage Level	05	05	05	05	05
9	$t_{CK} @ CL_{MAX}$ (Byte 18) [ns]	3D	3D	3D	3D	3D
10	t_{AC} SDRAM @ CL_{MAX} (Byte 18) [ns]	50	50	50	50	50
11	Error Correction Support (non-ECC, ECC)	00	00	00	00	02
12	Refresh Rate and Type	82	82	82	82	82
13	Primary SDRAM Width	10	10	08	08	08
14	Error Checking SDRAM Width	00	00	00	00	08
15	Not used	00	00	00	00	00
16	Burst Length Supported	0C	0C	0C	0C	0C
17	Number of Banks on SDRAM Device	04	04	04	04	04
18	Supported CAS Latencies	38	38	38	38	38
19	DIMM Mechanical Characteristics	00	00	00	00	00
20	DIMM Type Information	02	02	02	02	02
21	DIMM Attributes	00	00	00	00	00

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Product Type		HYS64T32000HU-3.7-A	HYS64T32900HU-3.7-A	HYS64T64000HU-3.7-A	HYS64T64900HU-3.7-A	HYS72T64000HU-3.7-A
Organization		256MB ×64 1 Rank (×16)	256MB ×64 1 Rank (×16)	512MB ×64 1 Rank (×8)	512MB ×64 1 Rank (×8)	512MB ×72 1 Rank (×8)
Label Code		PC2-4200U-444	PC2-4200U-444	PC2-4200U-444	PC2-4200U-444	PC2-4200E-444
JEDEC SPD Revision		Rev. 1.1	Rev. 1.2	Rev. 1.1	Rev. 1.2	Rev. 1.1
Byte#	Description	HEX	HEX	HEX	HEX	HEX
22	Component Attributes	01	03	01	03	01
23	$t_{CK} @ CL_{MAX} -1$ (Byte 18) [ns]	3D	3D	3D	3D	3D
24	t_{AC} SDRAM @ $CL_{MAX} -1$ [ns]	50	50	50	50	50
25	$t_{CK} @ CL_{MAX} -2$ (Byte 18) [ns]	50	50	50	50	50
26	t_{AC} SDRAM @ $CL_{MAX} -2$ [ns]	60	60	60	60	60
27	$t_{RP.MIN}$ [ns]	3C	3C	3C	3C	3C
28	$t_{RRD.MIN}$ [ns]	28	28	1E	1E	1E
29	$t_{RCD.MIN}$ [ns]	3C	3C	3C	3C	3C
30	$t_{RAS.MIN}$ [ns]	2D	2D	2D	2D	2D
31	Module Density per Rank	40	40	80	80	80
32	$t_{AS.MIN}$ and $t_{CS.MIN}$ [ns]	25	25	25	25	25
33	$t_{AH.MIN}$ and $t_{CH.MIN}$ [ns]	37	37	37	37	37
34	$t_{DS.MIN}$ [ns]	10	10	10	10	10
35	$t_{DH.MIN}$ [ns]	22	22	22	22	22
36	$t_{WR.MIN}$ [ns]	3C	3C	3C	3C	3C
37	$t_{WTR.MIN}$ [ns]	1E	1E	1E	1E	1E
38	$t_{RTP.MIN}$ [ns]	1E	1E	1E	1E	1E
39	Analysis Characteristics	00	00	00	00	00
40	t_{RC} and t_{RFC} Extension	00	00	00	00	00
41	$t_{RC.MIN}$ [ns]	3C	3C	3C	3C	3C
42	$t_{RFC.MIN}$ [ns]	69	69	69	69	69
43	$t_{CK.MAX}$ [ns]	80	80	80	80	80
44	$t_{DQSQ.MAX}$ [ns]	1E	1E	1E	1E	1E
45	$t_{QHS.MAX}$ [ns]	28	28	28	28	28

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Product Type		HYS64T32000HU-3.7-A	HYS64T32900HU-3.7-A	HYS64T64000HU-3.7-A	HYS64T64900HU-3.7-A	HYS72T64000HU-3.7-A
Organization		256MB ×64 1 Rank (×16)	256MB ×64 1 Rank (×16)	512MB ×64 1 Rank (×8)	512MB ×64 1 Rank (×8)	512MB ×72 1 Rank (×8)
Label Code		PC2-4200U-444	PC2-4200U-444	PC2-4200U-444	PC2-4200U-444	PC2-4200E-444
JEDEC SPD Revision		Rev. 1.1	Rev. 1.2	Rev. 1.1	Rev. 1.2	Rev. 1.1
Byte#	Description	HEX	HEX	HEX	HEX	HEX
46	PLL Relock Time	00	00	00	00	00
47	$T_{CASE,MAX}$ Delta / ΔT_{4R4W} Delta	53	53	51	51	51
48	Psi(T-A) DRAM	72	72	78	78	78
49	ΔT_0 (DT0)	53	53	3F	3F	3F
50	ΔT_{2N} (DT2N, UDIMM) or ΔT_{2Q} (DT2Q, RDIMM)	2B	2B	2E	2E	2E
51	ΔT_{2P} (DT2P)	1D	1D	1E	1E	1E
52	ΔT_{3N} (DT3N)	1D	1D	1E	1E	1E
53	$\Delta T_{3P,fast}$ (DT3P fast)	23	23	24	24	24
54	$\Delta T_{3P,slow}$ (DT3P slow)	16	16	17	17	17
55	ΔT_{4R} (DT4R) / ΔT_{4R4W} Sign (DT4R4W)	36	36	34	34	34
56	ΔT_{5B} (DT5B)	1C	1C	1E	1E	1E
57	ΔT_7 (DT7)	30	30	20	20	20
58	Psi(ca) PLL	00	00	00	00	00
59	Psi(ca) REG	00	00	00	00	00
60	ΔT_{PLL} (DTPLL)	00	00	00	00	00
61	ΔT_{REG} (DTREG) / Toggle Rate	00	00	00	00	00
62	SPD Revision	11	12	11	12	11
63	Checksum of Bytes 0-62	BA	BD	D0	D3	E2
64	Manufacturer's JEDEC ID Code (1)	7F	7F	7F	7F	7F
65	Manufacturer's JEDEC ID Code (2)	7F	7F	7F	7F	7F
66	Manufacturer's JEDEC ID Code (3)	7F	7F	7F	7F	7F
67	Manufacturer's JEDEC ID Code (4)	7F	7F	7F	7F	7F
68	Manufacturer's JEDEC ID Code (5)	7F	7F	7F	7F	7F
69	Manufacturer's JEDEC ID Code (6)	51	51	51	51	51



HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Product Type		HYS64T32000HU-3.7-A	HYS64T32900HU-3.7-A	HYS64T64000HU-3.7-A	HYS64T64900HU-3.7-A	HYS72T64000HU-3.7-A
Organization		256MB	256MB	512MB	512MB	512MB
		×64	×64	×64	×64	×72
		1 Rank (×16)	1 Rank (×16)	1 Rank (×8)	1 Rank (×8)	1 Rank (×8)
Label Code		PC2-4200U-444	PC2-4200U-444	PC2-4200U-444	PC2-4200U-444	PC2-4200E-444
JEDEC SPD Revision		Rev. 1.1	Rev. 1.2	Rev. 1.1	Rev. 1.2	Rev. 1.1
Byte#	Description	HEX	HEX	HEX	HEX	HEX
70	Manufacturer's JEDEC ID Code (7)	00	00	00	00	00
71	Manufacturer's JEDEC ID Code (8)	00	00	00	00	00
72	Module Manufacturer Location	xx	xx	xx	xx	xx
73	Product Type, Char 1	36	36	36	36	37
74	Product Type, Char 2	34	34	34	34	32
75	Product Type, Char 3	54	54	54	54	54
76	Product Type, Char 4	33	33	36	36	36
77	Product Type, Char 5	32	32	34	34	34
78	Product Type, Char 6	30	39	30	39	30
79	Product Type, Char 7	30	30	30	30	30
80	Product Type, Char 8	30	30	30	30	30
81	Product Type, Char 9	48	48	48	48	48
82	Product Type, Char 10	55	55	55	55	55
83	Product Type, Char 11	33	33	33	33	33
84	Product Type, Char 12	2E	2E	2E	2E	2E
85	Product Type, Char 13	37	37	37	37	37
86	Product Type, Char 14	41	41	41	41	41
87	Product Type, Char 15	20	20	20	20	20
88	Product Type, Char 16	20	20	20	20	20
89	Product Type, Char 17	20	20	20	20	20
90	Product Type, Char 18	20	20	20	20	20
91	Module Revision Code	5x	2x	5x	2x	5x
92	Test Program Revision Code	xx	xx	xx	xx	xx
93	Module Manufacturing Date Year	xx	xx	xx	xx	xx

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Product Type		HYS64T32000HU-3.7-A	HYS64T32900HU-3.7-A	HYS64T64000HU-3.7-A	HYS64T64900HU-3.7-A	HYS72T64000HU-3.7-A
Organization		256MB	256MB	512MB	512MB	512MB
		×64	×64	×64	×64	×72
		1 Rank (×16)	1 Rank (×16)	1 Rank (×8)	1 Rank (×8)	1 Rank (×8)
Label Code		PC2- 4200U- 444	PC2- 4200U- 444	PC2- 4200U- 444	PC2- 4200U- 444	PC2- 4200E- 444
JEDEC SPD Revision		Rev. 1.1	Rev. 1.2	Rev. 1.1	Rev. 1.2	Rev. 1.1
Byte#	Description	HEX	HEX	HEX	HEX	HEX
94	Module Manufacturing Date Week	xx	xx	xx	xx	xx
95 - 98	Module Serial Number	xx	xx	xx	xx	xx
99 - 127	Not used	00	00	00	00	00
128 - 255	Blank for customer use	FF	FF	FF	FF	FF

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

TABLE 32
HYS[64/72]T128x20HU-3.7-A

Product Type		HYS64T128020HU-3.7-A	HYS64T128920HU-3.7-A	HYS72T128020HU-3.7-A
Organization		1 GByte ×64 2 Ranks (×8)	1 GByte ×64 2 Ranks (×8)	1 GByte ×72 2 Ranks (×8)
Label Code		PC2-4200U-444	PC2-4200U-444	PC2-4200E-444
JEDEC SPD Revision		Rev. 1.1	Rev. 1.2	Rev. 1.1
Byte#	Description	HEX	HEX	HEX
0	Programmed SPD Bytes in EEPROM	80	80	80
1	Total number of Bytes in EEPROM	08	08	08
2	Memory Type (DDR2)	08	08	08
3	Number of Row Addresses	0E	0E	0E
4	Number of Column Addresses	0A	0A	0A
5	DIMM Rank and Stacking Information	61	61	61
6	Data Width	40	40	48
7	Not used	00	00	00
8	Interface Voltage Level	05	05	05
9	$t_{CK} @ CL_{MAX}$ (Byte 18) [ns]	3D	3D	3D
10	t_{AC} SDRAM @ CL_{MAX} (Byte 18) [ns]	50	50	50
11	Error Correction Support (non-ECC, ECC)	00	00	02
12	Refresh Rate and Type	82	82	82
13	Primary SDRAM Width	08	08	08
14	Error Checking SDRAM Width	00	00	08
15	Not used	00	00	00
16	Burst Length Supported	0C	0C	0C
17	Number of Banks on SDRAM Device	04	04	04
18	Supported CAS Latencies	38	38	38
19	DIMM Mechanical Characteristics	00	00	00
20	DIMM Type Information	02	02	02
21	DIMM Attributes	00	00	00
22	Component Attributes	01	03	01
23	$t_{CK} @ CL_{MAX} -1$ (Byte 18) [ns]	3D	3D	3D

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Product Type		HYS64T128020HU-3.7-A	HYS64T128920HU-3.7-A	HYS72T128020HU-3.7-A
Organization		1 GByte	1 GByte	1 GByte
		×64	×64	×72
		2 Ranks (×8)	2 Ranks (×8)	2 Ranks (×8)
Label Code		PC2-4200U-444	PC2-4200U-444	PC2-4200E-444
JEDEC SPD Revision		Rev. 1.1	Rev. 1.2	Rev. 1.1
Byte#	Description	HEX	HEX	HEX
24	t_{AC} SDRAM @ $CL_{MAX} -1$ [ns]	50	50	50
25	t_{CK} @ $CL_{MAX} -2$ (Byte 18) [ns]	50	50	50
26	t_{AC} SDRAM @ $CL_{MAX} -2$ [ns]	60	60	60
27	$t_{RP.MIN}$ [ns]	3C	3C	3C
28	$t_{RRD.MIN}$ [ns]	1E	1E	1E
29	$t_{RCD.MIN}$ [ns]	3C	3C	3C
30	$t_{RAS.MIN}$ [ns]	2D	2D	2D
31	Module Density per Rank	80	80	80
32	$t_{AS.MIN}$ and $t_{CS.MIN}$ [ns]	25	25	25
33	$t_{AH.MIN}$ and $t_{CH.MIN}$ [ns]	37	37	37
34	$t_{DS.MIN}$ [ns]	10	10	10
35	$t_{DH.MIN}$ [ns]	22	22	22
36	$t_{WR.MIN}$ [ns]	3C	3C	3C
37	$t_{WTR.MIN}$ [ns]	1E	1E	1E
38	$t_{RTP.MIN}$ [ns]	1E	1E	1E
39	Analysis Characteristics	00	00	00
40	t_{RC} and t_{RFC} Extension	00	00	00
41	$t_{RC.MIN}$ [ns]	3C	3C	3C
42	$t_{RFC.MIN}$ [ns]	69	69	69
43	$t_{CK.MAX}$ [ns]	80	80	80
44	$t_{DQSQ.MAX}$ [ns]	1E	1E	1E
45	$t_{QHS.MAX}$ [ns]	28	28	28
46	PLL Relock Time	00	00	00
47	$T_{CASE.MAX}$ Delta / ΔT_{4R4W} Delta	51	51	51
48	Psi(T-A) DRAM	78	78	78
49	ΔT_0 (DT0)	3F	3F	3F

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Product Type		HYS64T128020HU-3.7-A	HYS64T128020HU-3.7-A	HYS72T128020HU-3.7-A
Organization		1 GByte	1 GByte	1 GByte
		×64	×64	×72
		2 Ranks (×8)	2 Ranks (×8)	2 Ranks (×8)
Label Code		PC2-4200U-444	PC2-4200U-444	PC2-4200E-444
JEDEC SPD Revision		Rev. 1.1	Rev. 1.2	Rev. 1.1
Byte#	Description	HEX	HEX	HEX
50	ΔT_{2N} (DT2N, UDIMM) or ΔT_{2Q} (DT2Q, RDIMM)	2E	2E	2E
51	ΔT_{2P} (DT2P)	1E	1E	1E
52	ΔT_{3N} (DT3N)	1E	1E	1E
53	$\Delta T_{3P.fast}$ (DT3P fast)	24	24	24
54	$\Delta T_{3P.slow}$ (DT3P slow)	17	17	17
55	ΔT_{4R} (DT4R) / ΔT_{4R4W} Sign (DT4R4W)	34	34	34
56	ΔT_{5B} (DT5B)	1E	1E	1E
57	ΔT_7 (DT7)	20	20	20
58	Psi(ca) PLL	00	00	00
59	Psi(ca) REG	00	00	00
60	ΔT_{PLL} (DTPLL)	00	00	00
61	ΔT_{REG} (DTREG) / Toggle Rate	00	00	00
62	SPD Revision	11	12	11
63	Checksum of Bytes 0-62	D1	D4	E3
64	Manufacturer's JEDEC ID Code (1)	7F	7F	7F
65	Manufacturer's JEDEC ID Code (2)	7F	7F	7F
66	Manufacturer's JEDEC ID Code (3)	7F	7F	7F
67	Manufacturer's JEDEC ID Code (4)	7F	7F	7F
68	Manufacturer's JEDEC ID Code (5)	7F	7F	7F
69	Manufacturer's JEDEC ID Code (6)	51	51	51
70	Manufacturer's JEDEC ID Code (7)	00	00	00
71	Manufacturer's JEDEC ID Code (8)	00	00	00
72	Module Manufacturer Location	xx	xx	xx
73	Product Type, Char 1	36	36	37
74	Product Type, Char 2	34	34	32
75	Product Type, Char 3	54	54	54

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Product Type		HYS64T128020HU-3.7-A	HYS64T128920HU-3.7-A	HYS72T128020HU-3.7-A
Organization		1 GByte	1 GByte	1 GByte
		×64	×64	×72
		2 Ranks (×8)	2 Ranks (×8)	2 Ranks (×8)
Label Code		PC2-4200U-444	PC2-4200U-444	PC2-4200E-444
JEDEC SPD Revision		Rev. 1.1	Rev. 1.2	Rev. 1.1
Byte#	Description	HEX	HEX	HEX
76	Product Type, Char 4	31	31	31
77	Product Type, Char 5	32	32	32
78	Product Type, Char 6	38	38	38
79	Product Type, Char 7	30	39	30
80	Product Type, Char 8	32	32	32
81	Product Type, Char 9	30	30	30
82	Product Type, Char 10	48	48	48
83	Product Type, Char 11	55	55	55
84	Product Type, Char 12	33	33	33
85	Product Type, Char 13	2E	2E	2E
86	Product Type, Char 14	37	37	37
87	Product Type, Char 15	41	41	41
88	Product Type, Char 16	20	20	20
89	Product Type, Char 17	20	20	20
90	Product Type, Char 18	20	20	20
91	Module Revision Code	5x	2x	5x
92	Test Program Revision Code	xx	xx	xx
93	Module Manufacturing Date Year	xx	xx	xx
94	Module Manufacturing Date Week	xx	xx	xx
95 - 98	Module Serial Number	xx	xx	xx
99 - 127	Not used	00	00	00
128 - 255	Blank for customer use	FF	FF	FF

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

TABLE 33
HYS[64/72]T[32/64/128]0x0HU-5-A

Product Type		HYS64T32000HU-5-A	HYS64T64000HU-5-A	HYS72T64000HU-5-A	HYS64T128020HU-5-A	HYS72T128020HU-5-A
Organization		256MB ×64 1 Rank (×16)	512MB ×64 1 Rank (×8)	512MB ×72 1 Rank (×8)	1 GByte ×64 2 Ranks (×8)	1 GByte ×72 2 Ranks (×8)
Label Code		PC2-3200U-333	PC2-3200U-333	PC2-3200E-333	PC2-3200U-333	PC2-3200E-333
JEDEC SPD Revision		Rev. 1.1	Rev. 1.1	Rev. 1.1	Rev. 1.1	Rev. 1.1
Byte#	Description	HEX	HEX	HEX	HEX	HEX
0	Programmed SPD Bytes in EEPROM	80	80	80	80	80
1	Total number of Bytes in EEPROM	08	08	08	08	08
2	Memory Type (DDR2)	08	08	08	08	08
3	Number of Row Addresses	0D	0E	0E	0E	0E
4	Number of Column Addresses	0A	0A	0A	0A	0A
5	DIMM Rank and Stacking Information	60	60	60	61	61
6	Data Width	40	40	48	40	48
7	Not used	00	00	00	00	00
8	Interface Voltage Level	05	05	05	05	05
9	$t_{CK} @ CL_{MAX}$ (Byte 18) [ns]	50	50	50	50	50
10	t_{AC} SDRAM @ CL_{MAX} (Byte 18) [ns]	60	60	60	60	60
11	Error Correction Support (non-ECC, ECC)	00	00	02	00	02
12	Refresh Rate and Type	82	82	82	82	82
13	Primary SDRAM Width	10	08	08	08	08
14	Error Checking SDRAM Width	00	00	08	00	08
15	Not used	00	00	00	00	00
16	Burst Length Supported	0C	0C	0C	0C	0C
17	Number of Banks on SDRAM Device	04	04	04	04	04
18	Supported CAS Latencies	38	38	38	38	38
19	DIMM Mechanical Characteristics	00	00	00	00	00
20	DIMM Type Information	02	02	02	02	02
21	DIMM Attributes	00	00	00	00	00

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Product Type		HYS64T32000HU-5-A	HYS64T64000HU-5-A	HYS72T64000HU-5-A	HYS64T128020HU-5-A	HYS72T128020HU-5-A
Organization		256MB	512MB	512MB	1 GByte	1 GByte
		×64	×64	×72	×64	×72
		1 Rank (×16)	1 Rank (×8)	1 Rank (×8)	2 Ranks (×8)	2 Ranks (×8)
Label Code		PC2- 3200U- 333	PC2- 3200U- 333	PC2- 3200E- 333	PC2- 3200U- 333	PC2- 3200E- 333
JEDEC SPD Revision		Rev. 1.1	Rev. 1.1	Rev. 1.1	Rev. 1.1	Rev. 1.1
Byte#	Description	HEX	HEX	HEX	HEX	HEX
22	Component Attributes	01	01	01	01	01
23	$t_{CK} @ CL_{MAX} -1$ (Byte 18) [ns]	50	50	50	50	50
24	t_{AC} SDRAM @ $CL_{MAX} -1$ [ns]	60	60	60	60	60
25	$t_{CK} @ CL_{MAX} -2$ (Byte 18) [ns]	50	50	50	50	50
26	t_{AC} SDRAM @ $CL_{MAX} -2$ [ns]	60	60	60	60	60
27	$t_{RP.MIN}$ [ns]	3C	3C	3C	3C	3C
28	$t_{RRD.MIN}$ [ns]	28	1E	1E	1E	1E
29	$t_{RCD.MIN}$ [ns]	3C	3C	3C	3C	3C
30	$t_{RAS.MIN}$ [ns]	28	28	28	28	28
31	Module Density per Rank	40	80	80	80	80
32	$t_{AS.MIN}$ and $t_{CS.MIN}$ [ns]	35	35	35	35	35
33	$t_{AH.MIN}$ and $t_{CH.MIN}$ [ns]	47	47	47	47	47
34	$t_{DS.MIN}$ [ns]	15	15	15	15	15
35	$t_{DH.MIN}$ [ns]	27	27	27	27	27
36	$t_{WR.MIN}$ [ns]	3C	3C	3C	3C	3C
37	$t_{WTR.MIN}$ [ns]	28	28	28	28	28
38	$t_{RTP.MIN}$ [ns]	1E	1E	1E	1E	1E
39	Analysis Characteristics	00	00	00	00	00
40	t_{RC} and t_{RFC} Extension	00	00	00	00	00
41	$t_{RC.MIN}$ [ns]	37	37	37	37	37
42	$t_{RFC.MIN}$ [ns]	69	69	69	69	69
43	$t_{CK.MAX}$ [ns]	80	80	80	80	80
44	$t_{DQSQ.MAX}$ [ns]	23	23	23	23	23
45	$t_{QHS.MAX}$ [ns]	2D	2D	2D	2D	2D

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Product Type		HYS64T32000HU-5-A	HYS64T64000HU-5-A	HYS72T64000HU-5-A	HYS64T128020HU-5-A	HYS72T128020HU-5-A
Organization		256MB	512MB	512MB	1 GByte	1 GByte
		×64	×64	×72	×64	×72
		1 Rank (×16)	1 Rank (×8)	1 Rank (×8)	2 Ranks (×8)	2 Ranks (×8)
Label Code		PC2-3200U-333	PC2-3200U-333	PC2-3200E-333	PC2-3200U-333	PC2-3200E-333
JEDEC SPD Revision		Rev. 1.1	Rev. 1.1	Rev. 1.1	Rev. 1.1	Rev. 1.1
Byte#	Description	HEX	HEX	HEX	HEX	HEX
46	PLL Relock Time	00	00	00	00	00
47	$T_{CASE,MAX}$ Delta / ΔT_{4R4W} Delta	51	51	51	51	51
48	Psi(T-A) DRAM	72	78	78	78	78
49	ΔT_0 (DT0)	43	33	33	33	33
50	ΔT_{2N} (DT2N, UDIMM) or ΔT_{2Q} (DT2Q, RDIMM)	23	24	24	24	24
51	ΔT_{2P} (DT2P)	1D	1E	1E	1E	1E
52	ΔT_{3N} (DT3N)	19	1B	1B	1B	1B
53	$\Delta T_{3P,fast}$ (DT3P fast)	1C	1E	1E	1E	1E
54	$\Delta T_{3P,slow}$ (DT3P slow)	16	17	17	17	17
55	ΔT_{4R} (DT4R) / ΔT_{4R4W} Sign (DT4R4W)	2E	28	28	28	28
56	ΔT_{5B} (DT5B)	1A	1B	1B	1B	1B
57	ΔT_7 (DT7)	2D	1E	1E	1E	1E
58	Psi(ca) PLL	00	00	00	00	00
59	Psi(ca) REG	00	00	00	00	00
60	ΔT_{PLL} (DTPLL)	00	00	00	00	00
61	ΔT_{REG} (DTREG) / Toggle Rate	00	00	00	00	00
62	SPD Revision	11	11	11	11	11
63	Checksum of Bytes 0-62	02	1A	2C	1B	2D
64	Manufacturer's JEDEC ID Code (1)	7F	7F	7F	7F	7F
65	Manufacturer's JEDEC ID Code (2)	7F	7F	7F	7F	7F
66	Manufacturer's JEDEC ID Code (3)	7F	7F	7F	7F	7F
67	Manufacturer's JEDEC ID Code (4)	7F	7F	7F	7F	7F
68	Manufacturer's JEDEC ID Code (5)	7F	7F	7F	7F	7F
69	Manufacturer's JEDEC ID Code (6)	51	51	51	51	51

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Product Type		HYS64T32000HU-5-A	HYS64T64000HU-5-A	HYS72T64000HU-5-A	HYS64T128020HU-5-A	HYS72T128020HU-5-A
Organization		256MB	512MB	512MB	1 GByte	1 GByte
		×64	×64	×72	×64	×72
		1 Rank (×16)	1 Rank (×8)	1 Rank (×8)	2 Ranks (×8)	2 Ranks (×8)
Label Code		PC2- 3200U- 333	PC2- 3200U- 333	PC2- 3200E- 333	PC2- 3200U- 333	PC2- 3200E- 333
JEDEC SPD Revision		Rev. 1.1	Rev. 1.1	Rev. 1.1	Rev. 1.1	Rev. 1.1
Byte#	Description	HEX	HEX	HEX	HEX	HEX
70	Manufacturer's JEDEC ID Code (7)	00	00	00	00	00
71	Manufacturer's JEDEC ID Code (8)	00	00	00	00	00
72	Module Manufacturer Location	xx	xx	xx	xx	xx
73	Product Type, Char 1	36	36	37	36	37
74	Product Type, Char 2	34	34	32	34	32
75	Product Type, Char 3	54	54	54	54	54
76	Product Type, Char 4	33	36	36	31	31
77	Product Type, Char 5	32	34	34	32	32
78	Product Type, Char 6	30	30	30	38	38
79	Product Type, Char 7	30	30	30	30	30
80	Product Type, Char 8	30	30	30	32	32
81	Product Type, Char 9	48	48	48	30	30
82	Product Type, Char 10	55	55	55	48	48
83	Product Type, Char 11	35	35	35	55	55
84	Product Type, Char 12	41	41	41	35	35
85	Product Type, Char 13	20	20	20	41	41
86	Product Type, Char 14	20	20	20	20	20
87	Product Type, Char 15	20	20	20	20	20
88	Product Type, Char 16	20	20	20	20	20
89	Product Type, Char 17	20	20	20	20	20
90	Product Type, Char 18	20	20	20	20	20
91	Module Revision Code	5x	5x	5x	5x	5x
92	Test Program Revision Code	xx	xx	xx	xx	xx
93	Module Manufacturing Date Year	xx	xx	xx	xx	xx



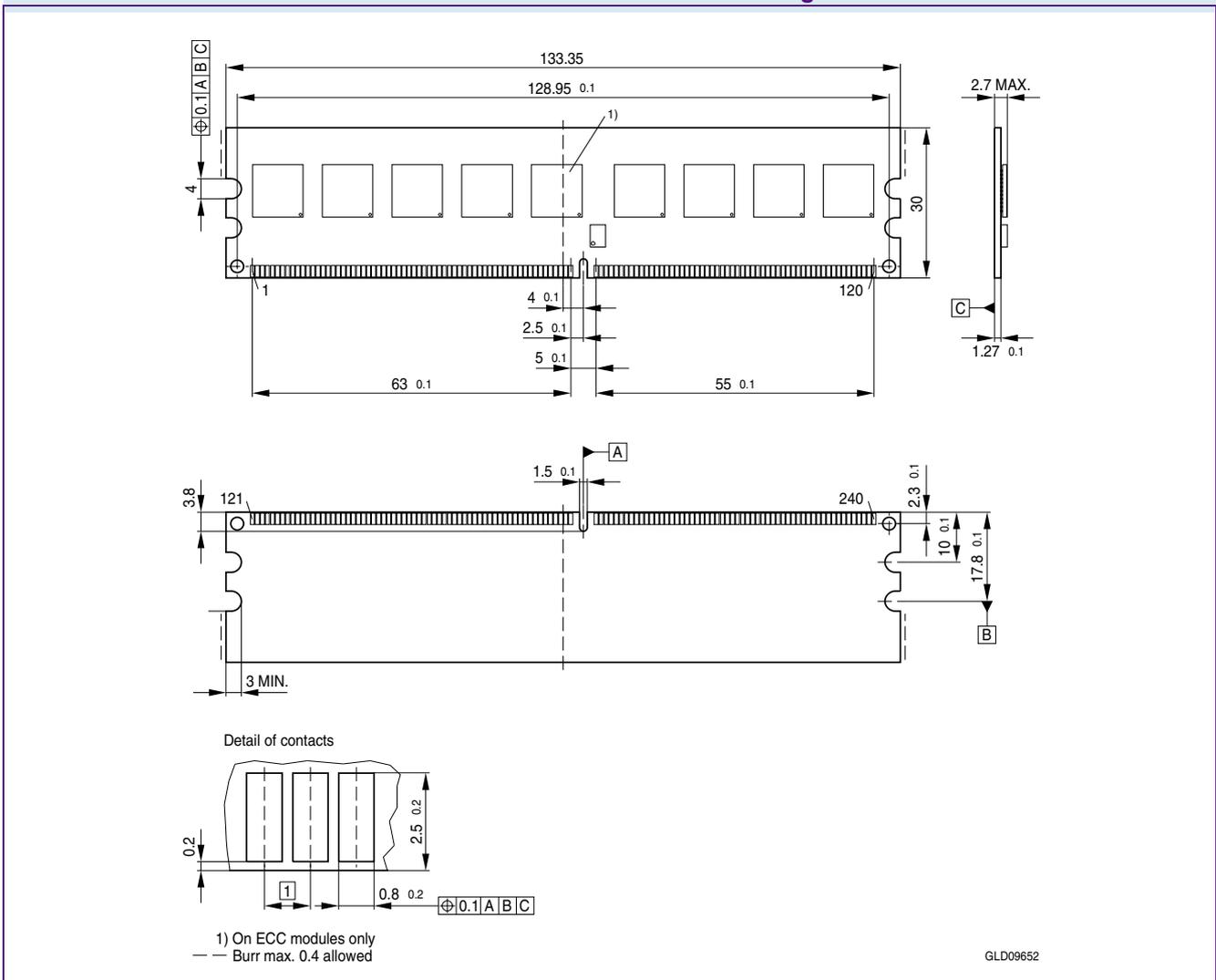
HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Product Type		HYS64T32000HU-5-A	HYS64T64000HU-5-A	HYS72T64000HU-5-A	HYS64T128020HU-5-A	HYS72T128020HU-5-A
Organization		256MB	512MB	512MB	1 GByte	1 GByte
		×64	×64	×72	×64	×72
		1 Rank (×16)	1 Rank (×8)	1 Rank (×8)	2 Ranks (×8)	2 Ranks (×8)
Label Code		PC2-3200U-333	PC2-3200U-333	PC2-3200E-333	PC2-3200U-333	PC2-3200E-333
JEDEC SPD Revision		Rev. 1.1	Rev. 1.1	Rev. 1.1	Rev. 1.1	Rev. 1.1
Byte#	Description	HEX	HEX	HEX	HEX	HEX
94	Module Manufacturing Date Week	xx	xx	xx	xx	xx
95 - 98	Module Serial Number	xx	xx	xx	xx	xx
99 - 127	Not used	00	00	00	00	00
128 - 255	Blank for customer use	FF	FF	FF	FF	FF

5 Package Outlines

This chapter contains the package outlines of the products.

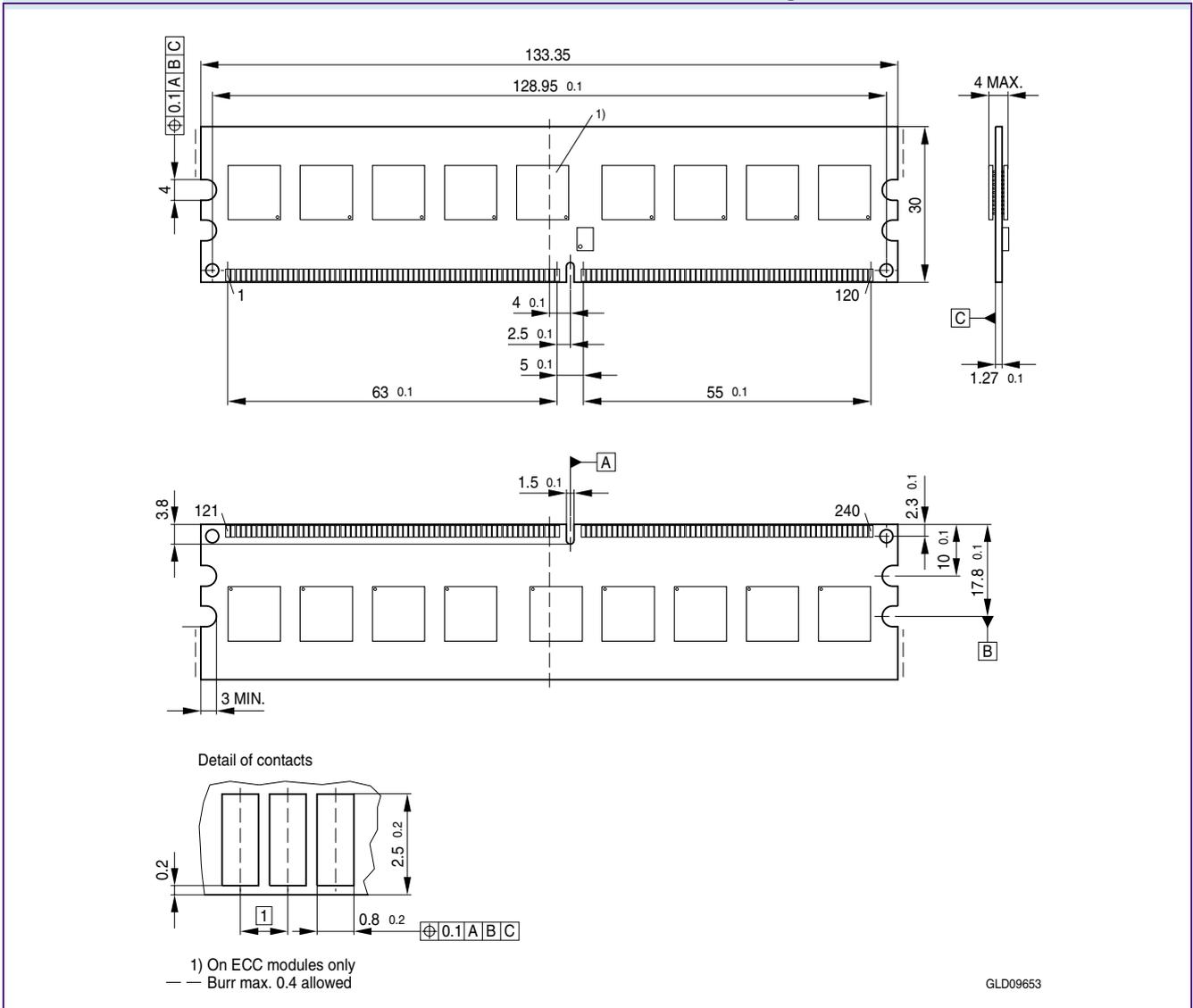
FIGURE 6
Package Outline Raw Card A L-DIM-240-1



Notes

1. Drawing according to ISO 8015
2. Dimensions in mm
3. General tolerances +/- 0.15

FIGURE 7
Package Outline Raw Card B L-DIM-240-2

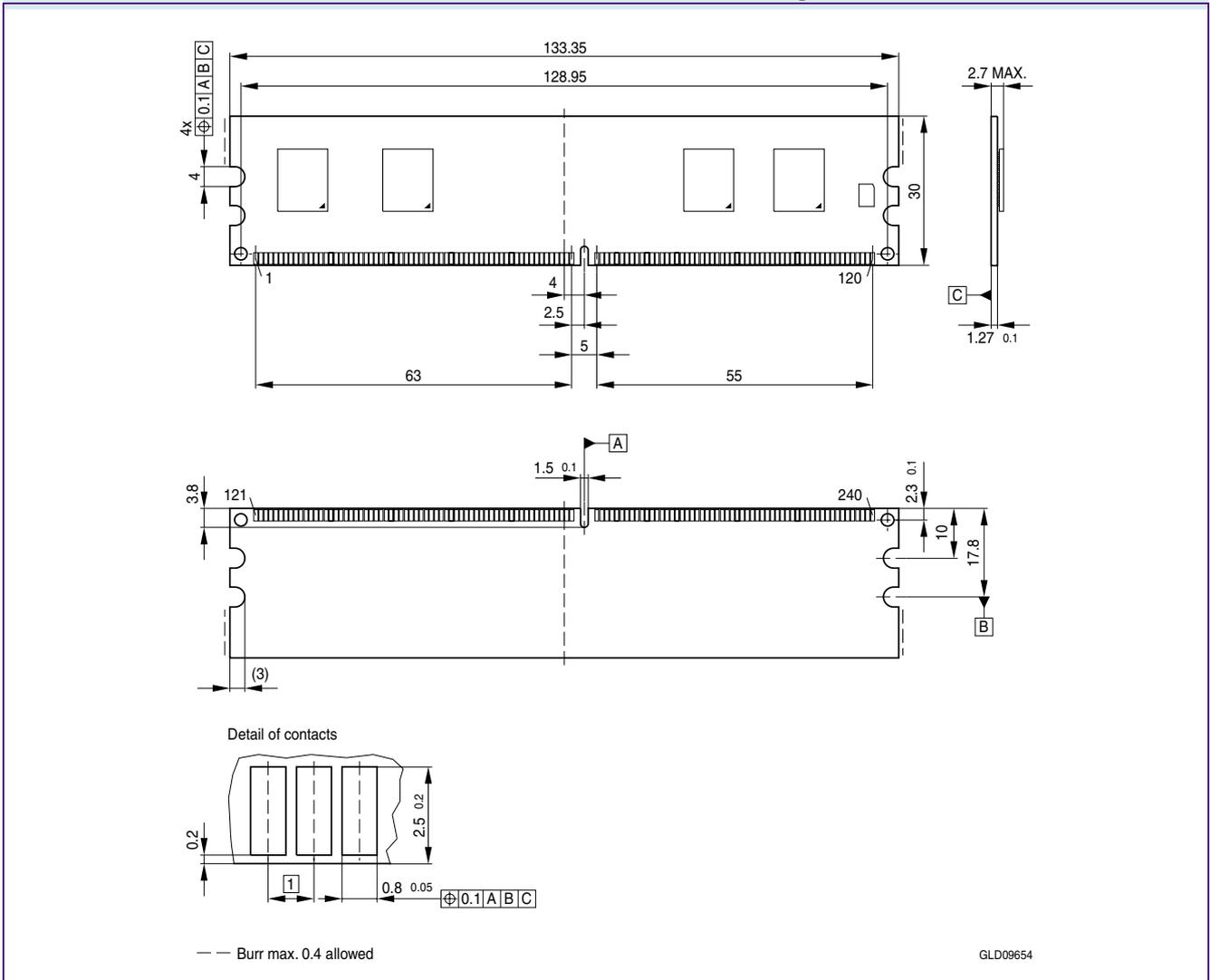


Notes

1. The chip is only found on ECC modules.
2. Drawing according to ISO 8015
3. Dimensions in mm
4. General tolerances +/- 0.15

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

FIGURE 8
Package Outline Raw Card C L-DIM-240-3

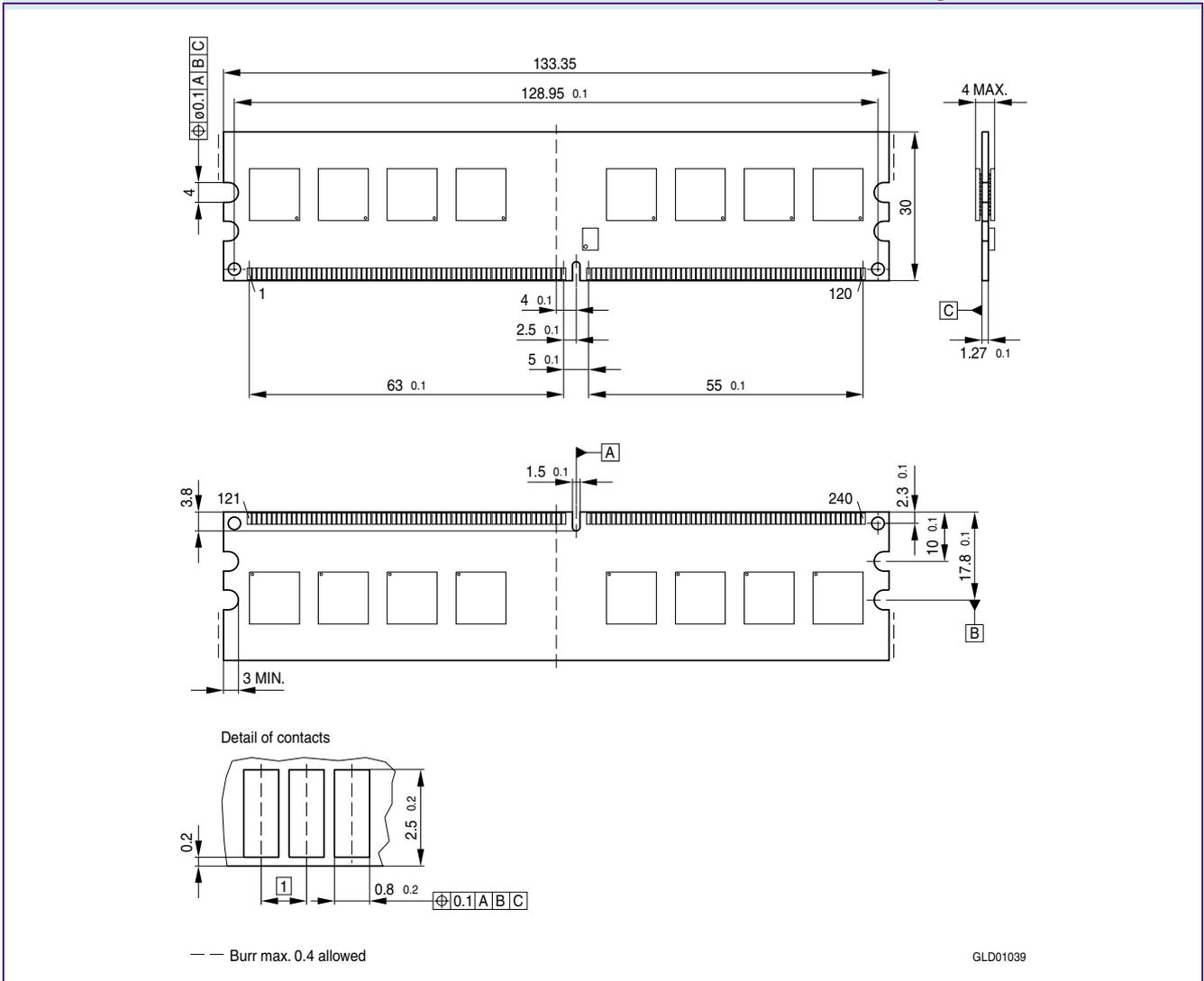


Notes

1. Drawing according to ISO 8015
2. Dimensions in mm
3. General tolerances +/- 0.15

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

FIGURE 10
Package Outline L-DIM-240-9

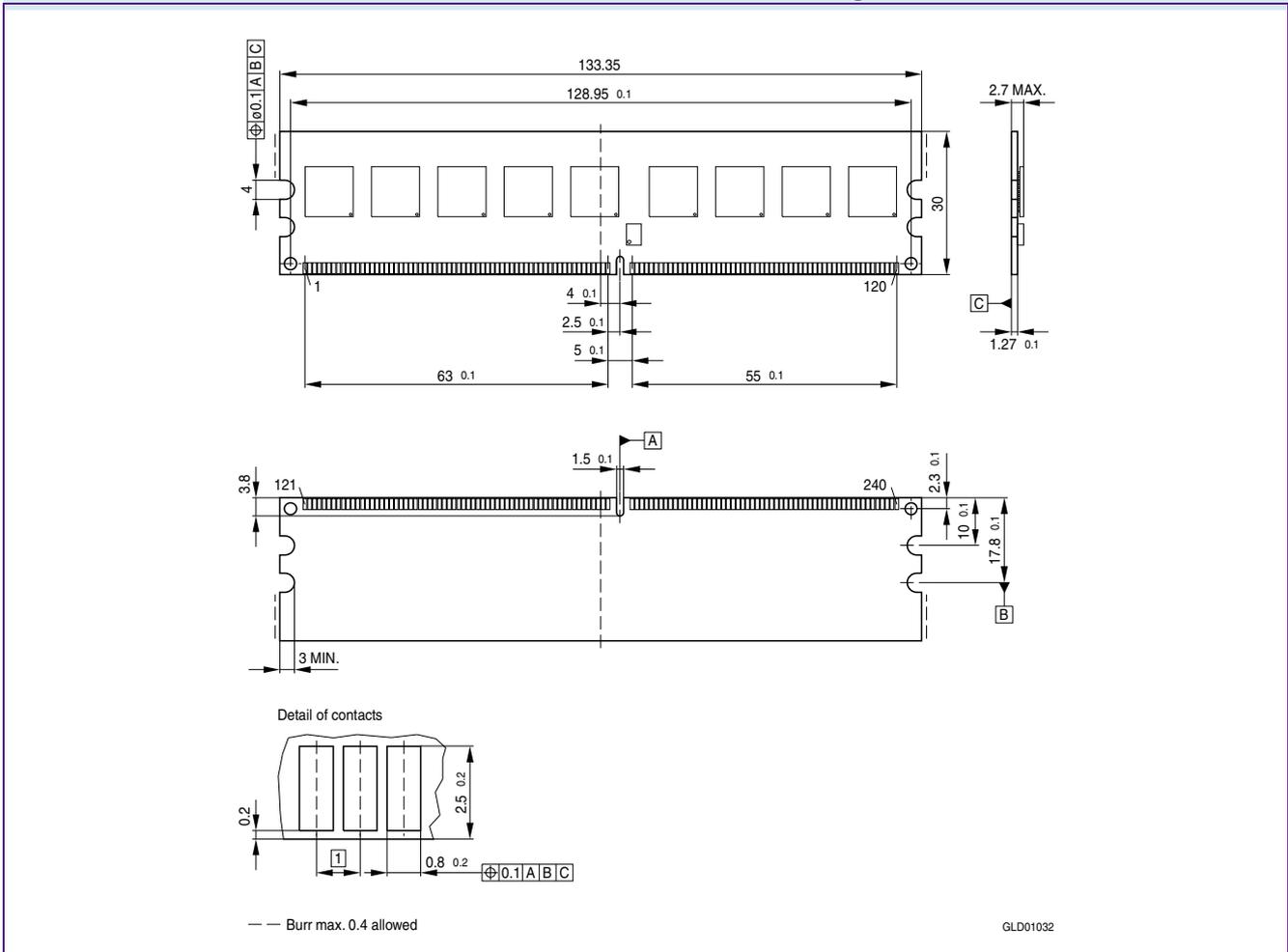


Notes

1. Drawing according to ISO 8015
2. Dimensions in mm
3. General tolerances +/- 0.15

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

FIGURE 11
Package Outline Raw Card F L-DIM-240-6

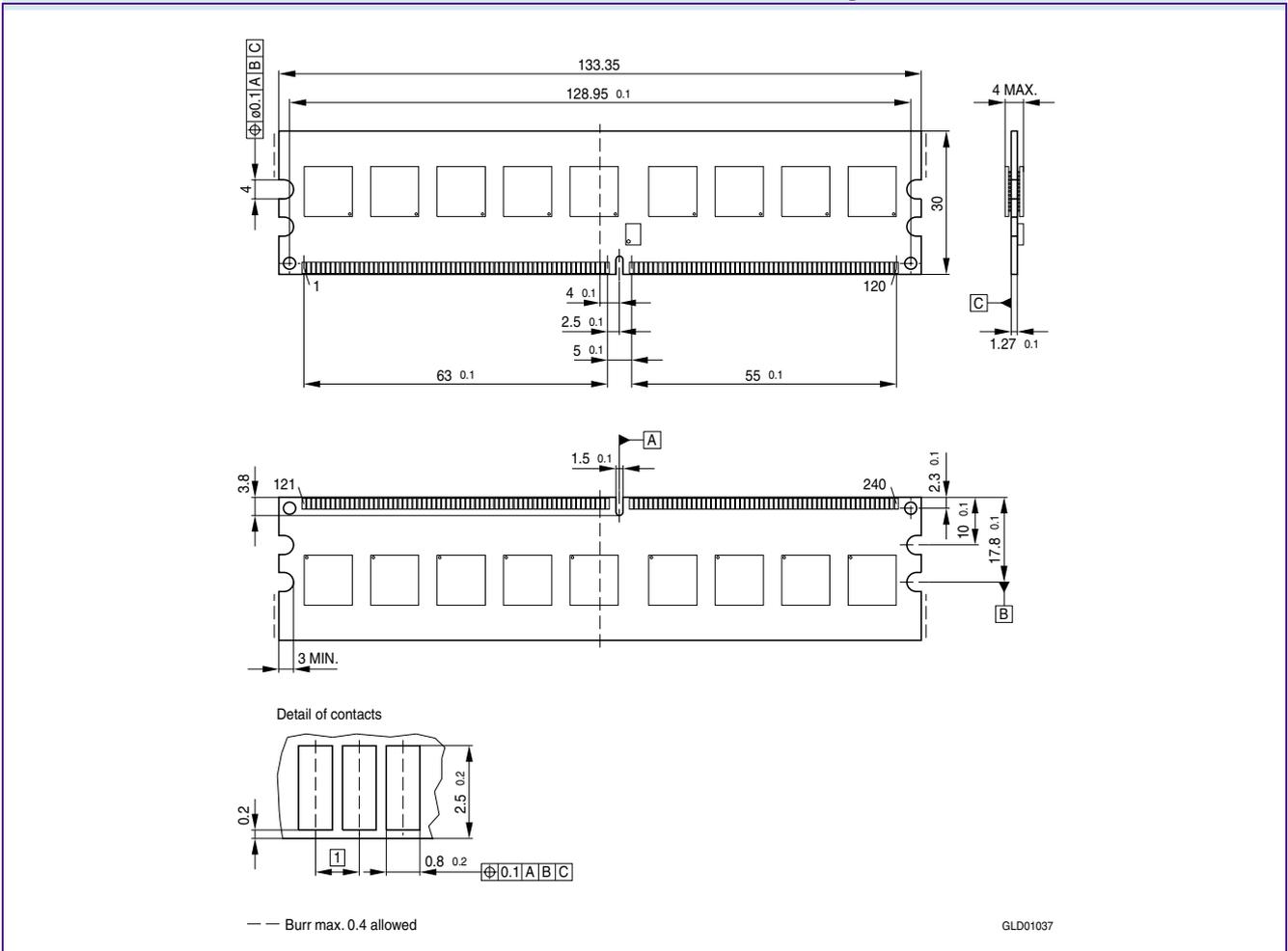


Notes

1. Drawing according to ISO 8015
2. Dimensions in mm
3. General tolerances +/- 0.15

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

FIGURE 12
Package Outline Raw Card G L-DIM-240-7



Notes

1. Drawing according to ISO 8015
2. Dimensions in mm
3. General tolerances +/- 0.15

6 Product Type Nomenclature

Qimonda's nomenclature uses simple coding combined with some proprietary coding. **Table 34** provides examples for module and component product type number as well as the field number. The detailed field description together with possible values and coding explanation is listed for modules in **Table 35** and for components in **Table 36**.

TABLE 34
Nomenclature Fields and Examples

Example for	Field Number										
	1	2	3	4	5	6	7	8	9	10	11
Micro-DIMM	HYS	64	T	64/128	0	2	0	K	M	-5	-A
DDR2 DRAM	HYB	18	T	512/1G	16		0	A	C	-5	

TABLE 35
DDR2 DIMM Nomenclature

Field	Description	Values	Coding
1	Qimonda Module Prefix	HYS	Constant
2	Module Data Width [bit]	64	Non-ECC
		72	ECC
3	DRAM Technology	T	DDR2
4	Memory Density per I/O [Mbit]; Module Density ¹⁾	32	256 MByte
		64	512 MByte
		128	1 GByte
		256	2 GByte
		512	4 GByte
5	Raw Card Generation	0 .. 9	Look up table
6	Number of Module Ranks	0, 2, 4	1, 2, 4
7	Product Variations	0 .. 9	Look up table
8	Package, Lead-Free Status	A .. Z	Look up table
9	Module Type	D	SO-DIMM
		M	Micro-DIMM
		R	Registered
		U	Unbuffered
		F	Fully Buffered

HYS[64/72]T[32/64/128]xx0HU-[3/3S/3.7/5]-A
Unbuffered DDR2 SDRAM Modules

Field	Description	Values	Coding
10	Speed Grade	-2.5F	PC2-6400 5-5-5
		-2.5	PC2-6400 6-6-6
		-3	PC2-5300 4-4-4
		-3S	PC2-5300 5-5-5
		-3.7	PC2-4200 4-4-4
		-5	PC2-3200 3-3-3
11	Die Revision	-A	First
		-B	Second

1) Multiplying "Memory Density per I/O" with "Module Data Width" and dividing by 8 for Non-ECC and 9 for ECC modules gives the overall module memory density in MBytes as listed in column "Coding".

TABLE 36
DDR2 DRAM Nomenclature

Field	Description	Values	Coding
1	Qimonda Component Prefix	HYB	Constant
2	Interface Voltage [V]	18	SSTL_18
3	DRAM Technology	T	DDR2
4	Component Density [Mbit]	256	256 Mbit
		512	512 Mbit
		1G	1 Gbit
		2G	2 Gbit
5+6	Number of I/Os	40	×4
		80	×8
		16	×16
7	Product Variations	0 .. 9	Look up table
8	Die Revision	A	First
		B	Second
9	Package, Lead-Free Status	C	FBGA, lead-containing
		F	FBGA, lead-free
10	Speed Grade	-25F	DDR2-800 5-5-5
		-2.5	DDR2-800 6-6-6
		-3	DDR2-667 4-4-4
		-3S	DDR2-667 5-5-5
		-3.7	DDR2-533 4-4-4
		-5	DDR2-400 3-3-3

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